

Instrumentations based on DVD Optical Pickup Unit (OPU)

Edwin Hwu
2014/06/04



Outline

- Astigmatic Detection Mechanism
- ADS based instrumentation
 - Scanning Probe Microscope
 - Laser Vibrometer
 - High Throughput Bio-sensing System
- Conclusions

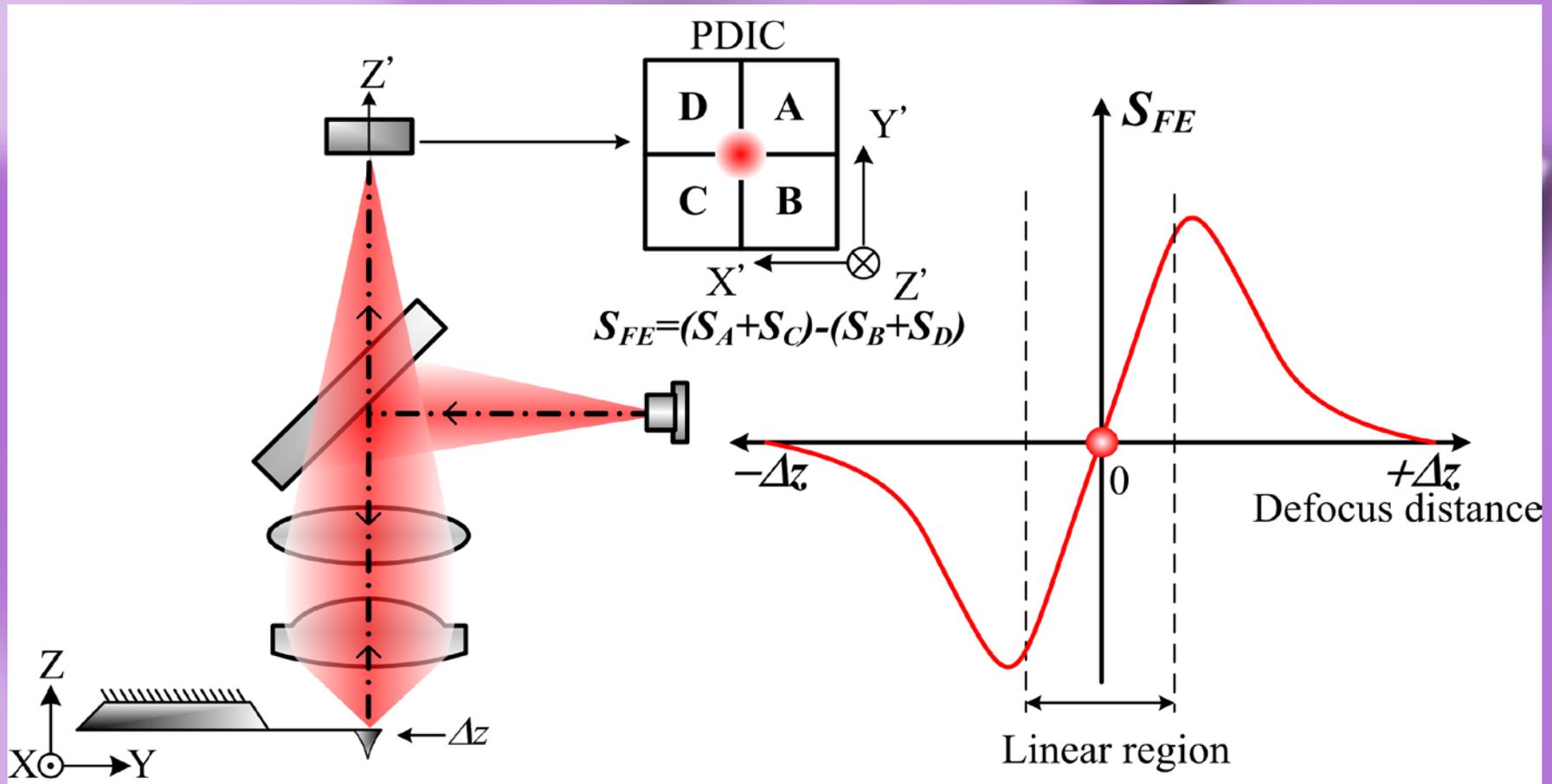


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Astigmatic detection mechanism inside the OPU



Applied Physics Letters, Vol. 91, No. 221908. (2007)

Surface and Nano Science Lab

Institute of Physics, Academia Sinica, Taipei, Taiwan

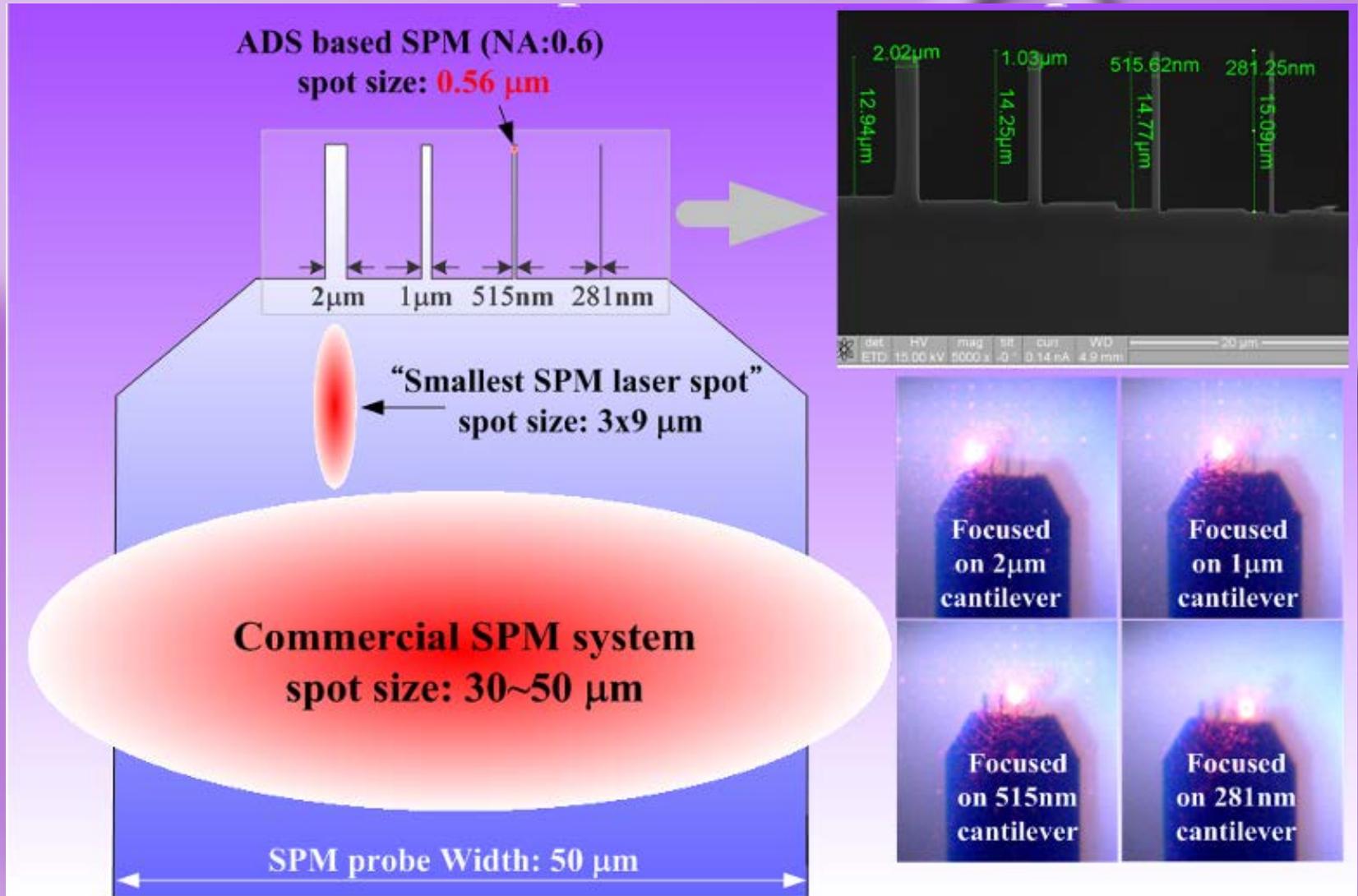


Comparison of Detection Mechanism

	Beam deflection method	Astigmatic method (DVD optical pickup unit)
Size comparison		
Mechanism	Beam deflection	Astigmatism
Laser spot size	30~50μm	0.5μm
Production cost	USD 5,000	USD 10
Z Resolution	0.01 nm	0.01 nm
Detection bandwidth	~ 5 MHz	80~100 MHz
Volume	250 cm³	9 cm³
Weight	~ 500 g	~20 g



Comparison of Laser Spot Size



The OPU can be a very precise transducer called
Astigmatic detection System (ADS)
for nano-scale applications

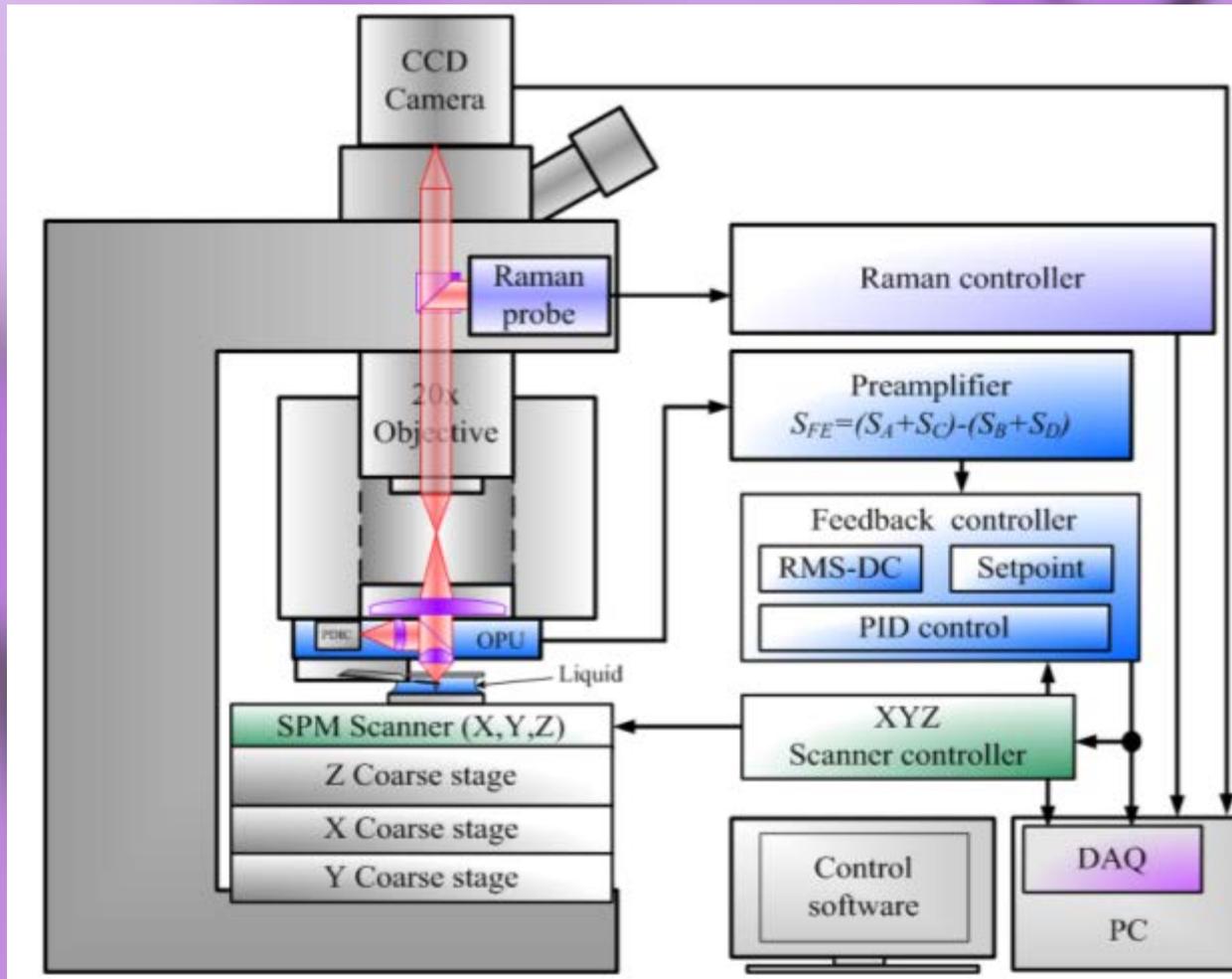


Outline

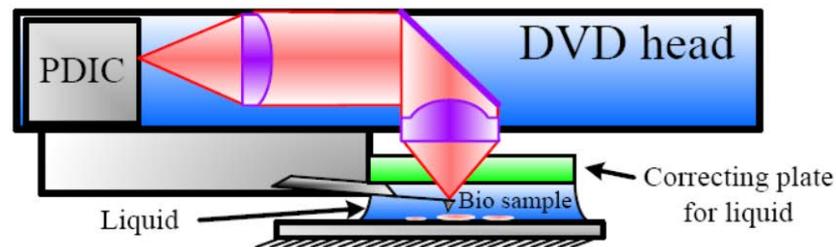
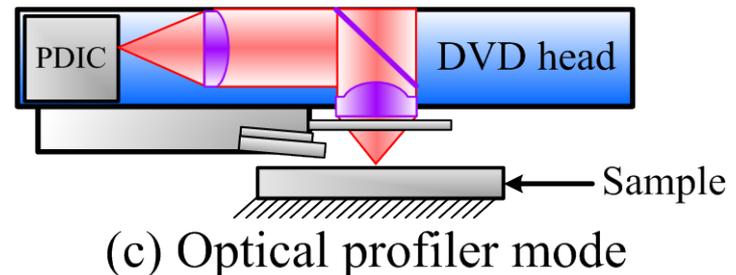
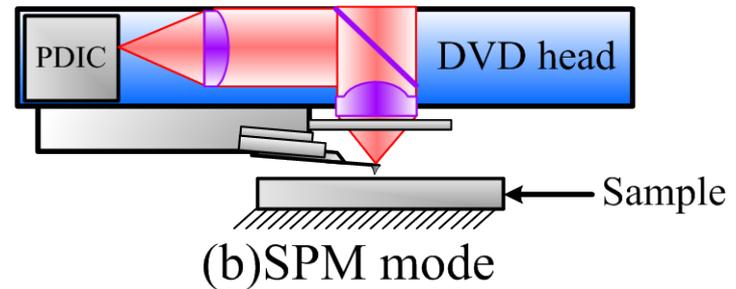
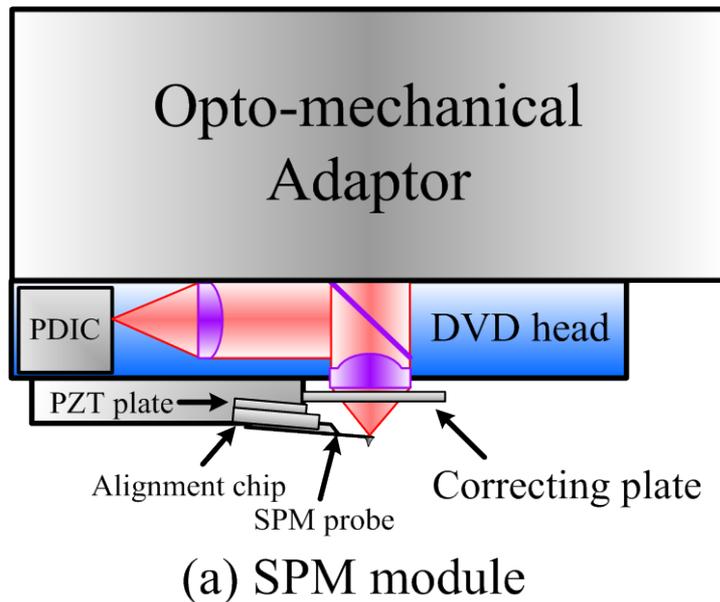
- Astigmatic Detection Mechanism
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ADS Based SPM Combined with Commercial Optical Microscope



ADS Based Hybrid SPM Head

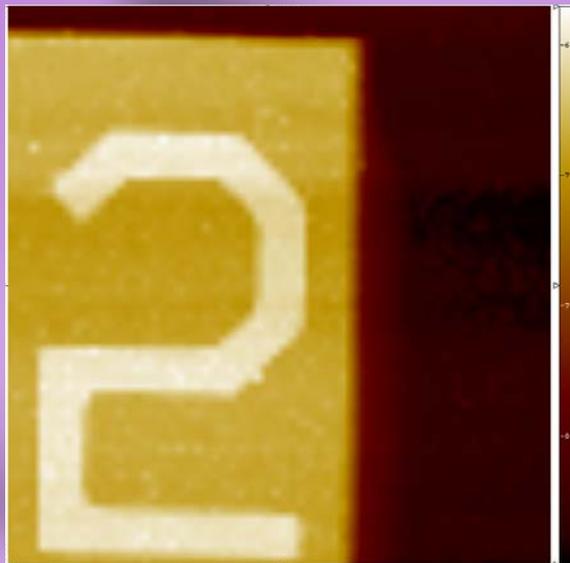


SPM Module Multi-mode Measurement

800nm Height standard measurement (Topography area: 100x100 μm)



SPM contact mode



SPM Tapping mode



Optical profiler mode

2007-2009@Physikalisch-Technische Bundesanstalt (PTB)

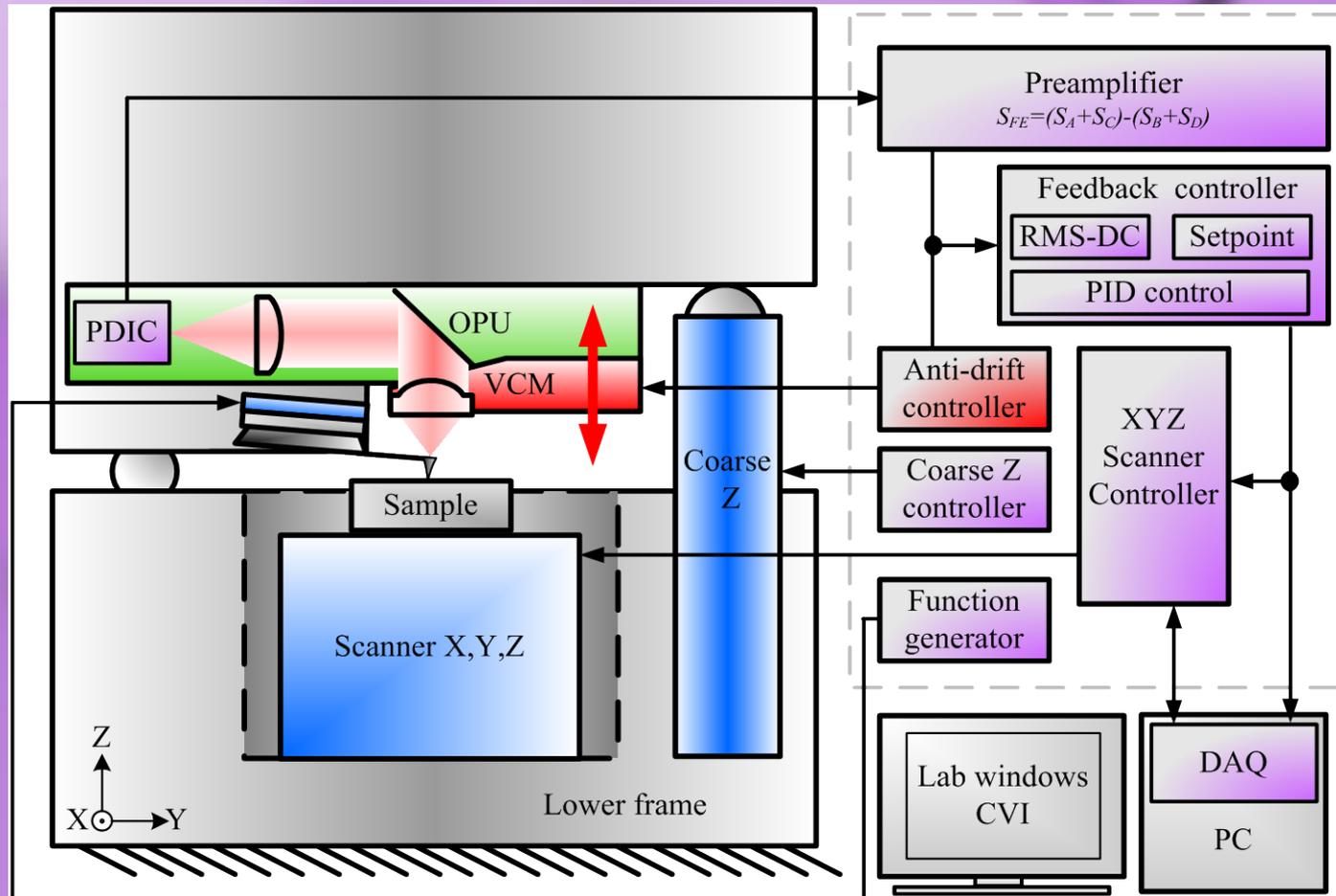
Measurement Science and Technology, 20 (2009) 084005

Surface and Nano Science Lab

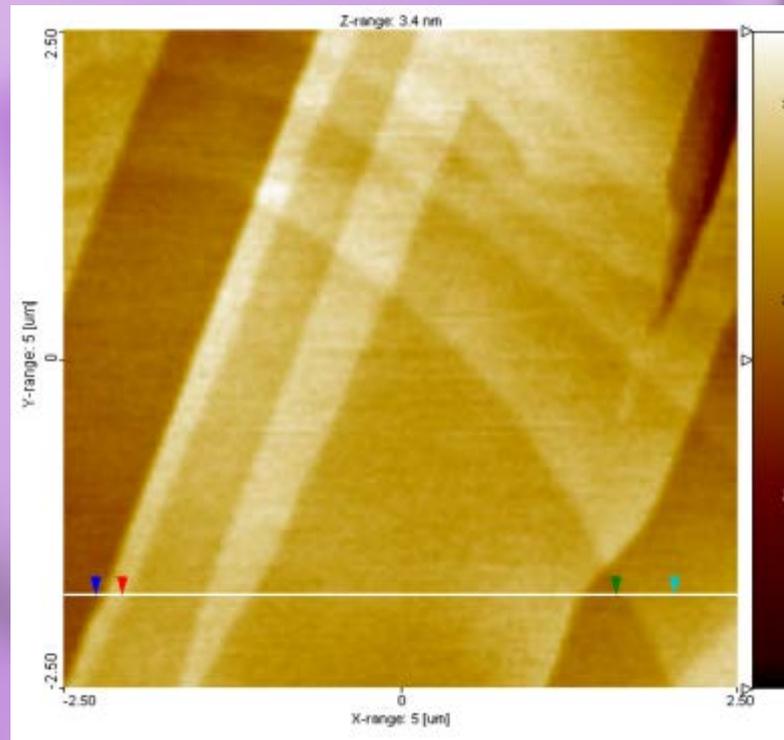
Institute of Physics, Academia Sinica, Taipei, Taiwan



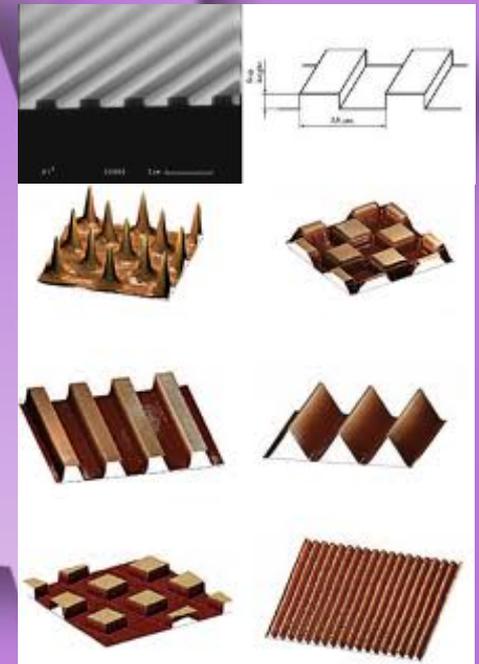
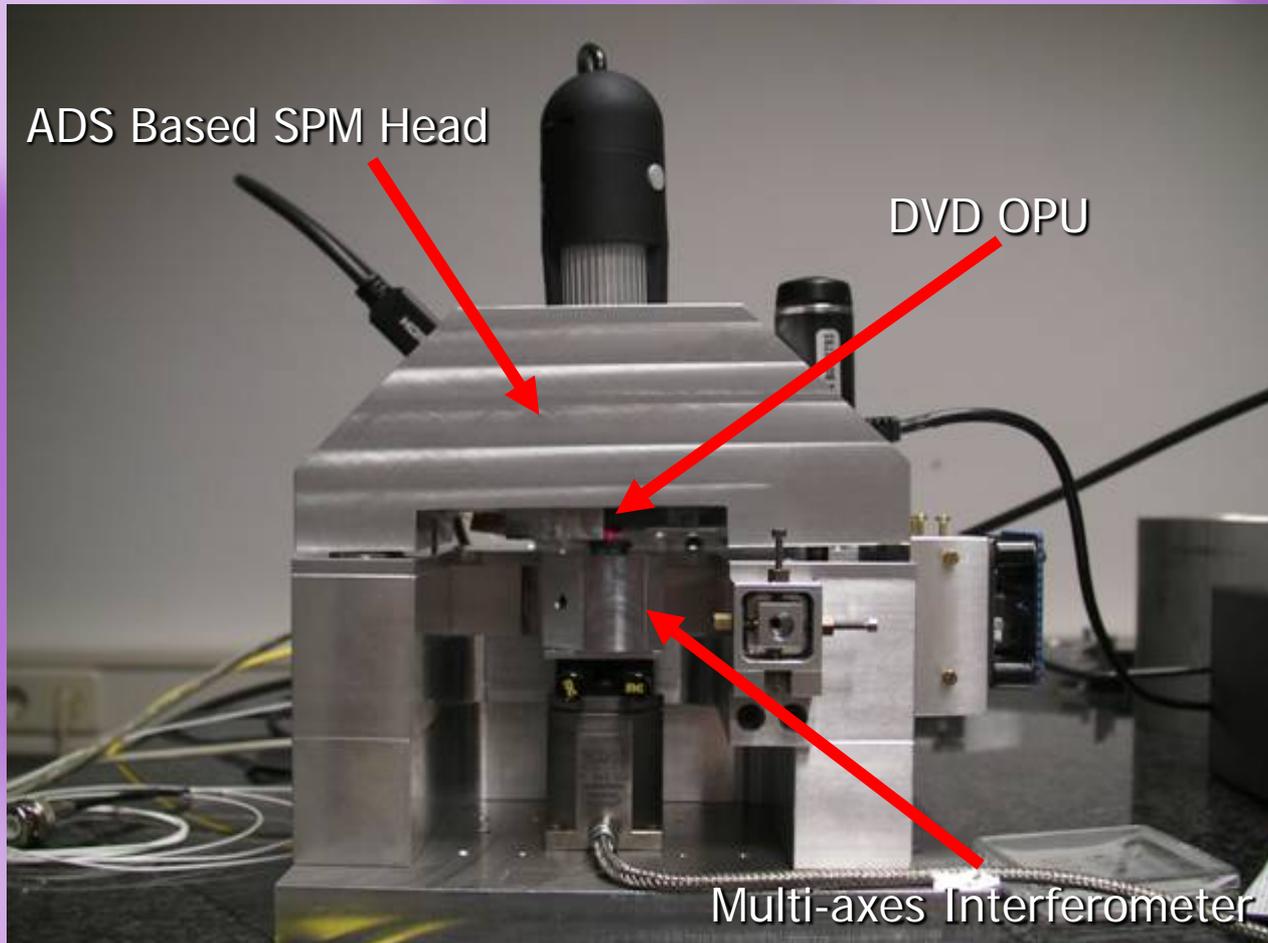
ADS Based AFM for Atomic Scale Measurement



HOPG single atomic layers

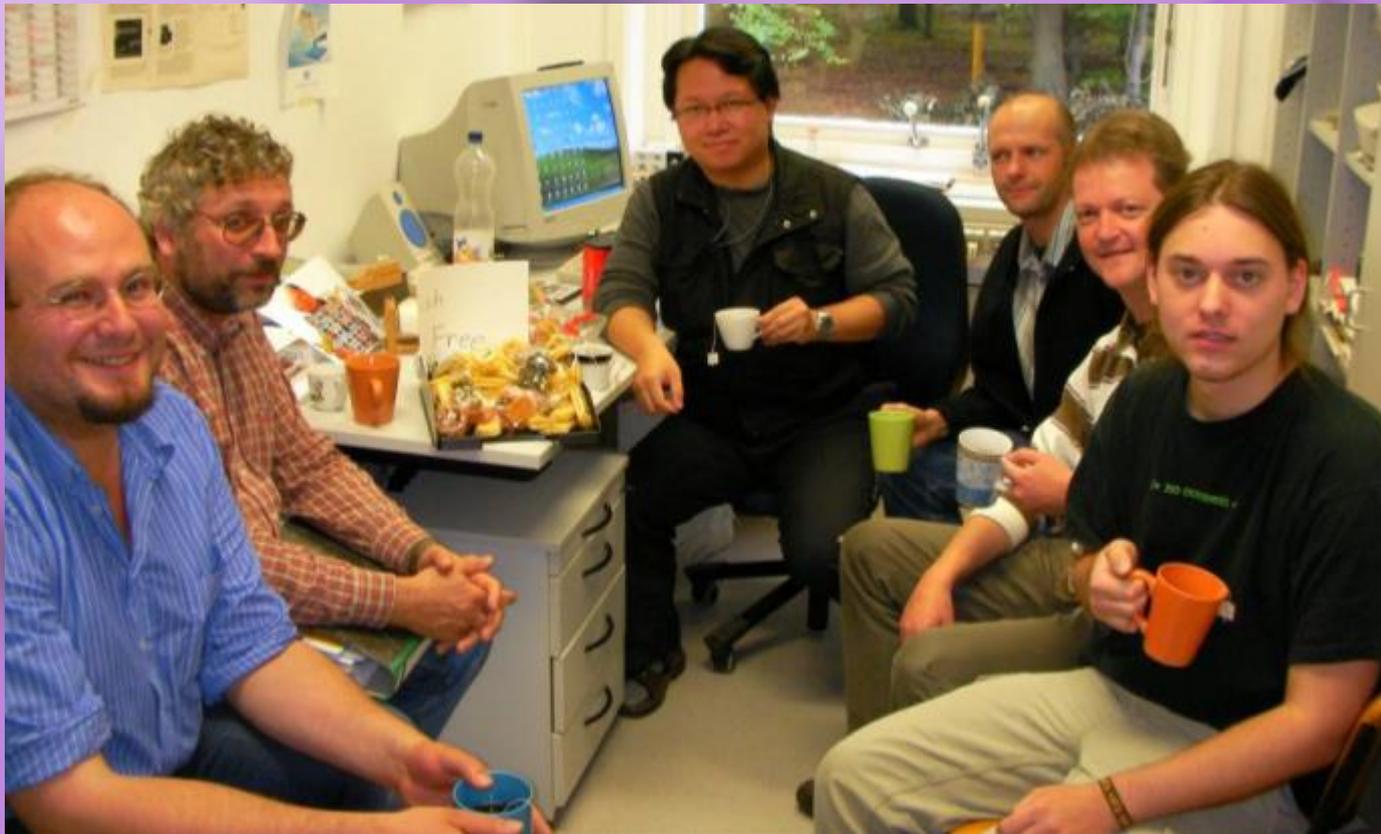


Pico-meter Scale Quantitative Scanning Probe Metrology System



To "Calibrate"
the Calibration Samples



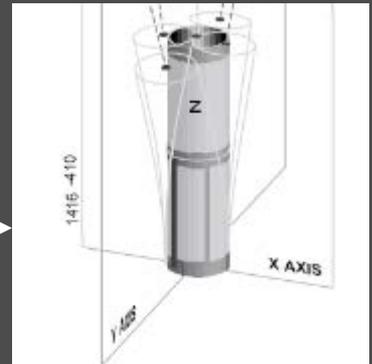


Physikalisch Technische Bundesanstalt (德國國家量測中心)
Surface and Nano Science Lab
Institute of Physics, Academia Sinica, Taipei, Taiwan



Low Voltage Piezoelectric Scanner

Traditional tube scanner:

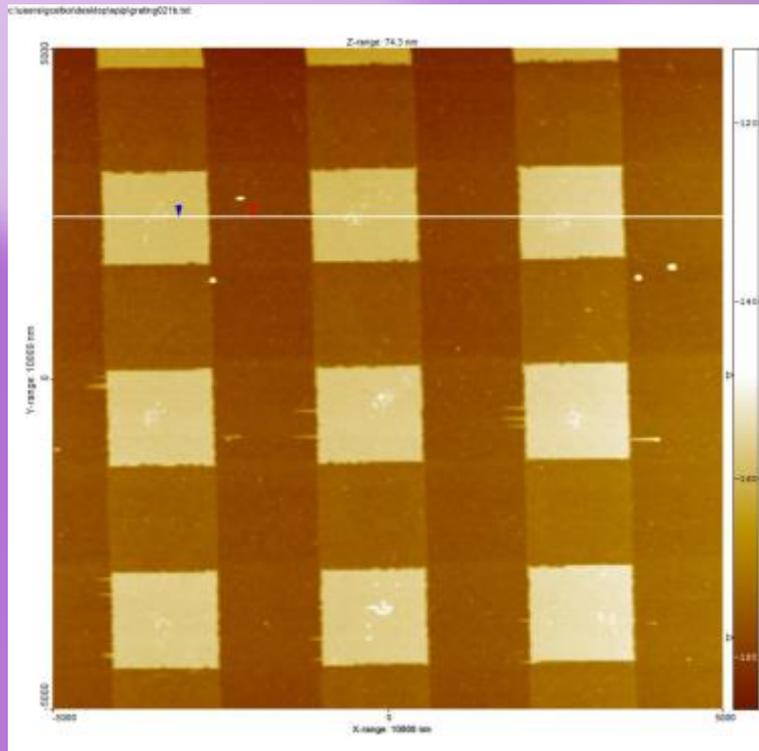


New developed low voltage scanner:

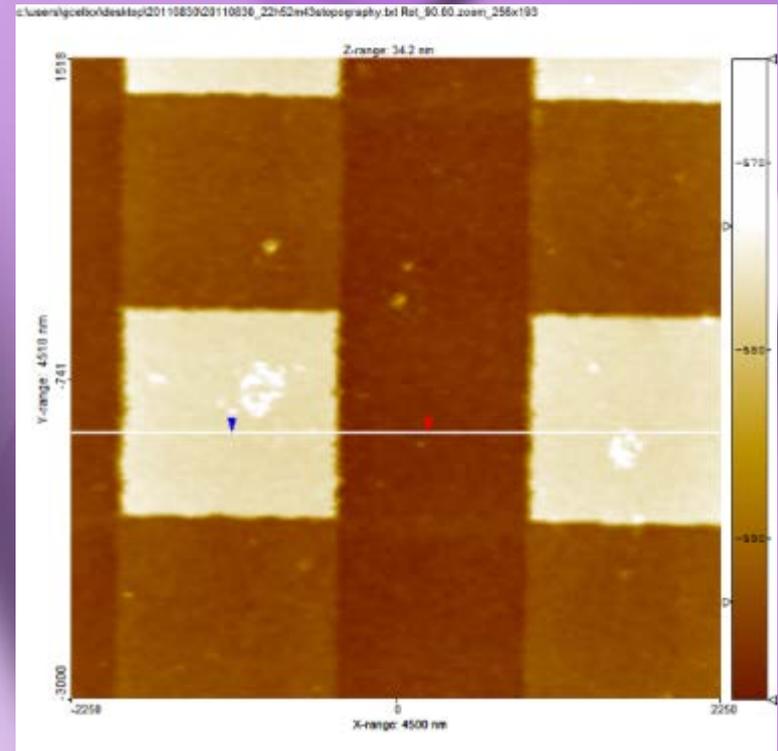


Comparison of measurement result

Traditional tube scanner:



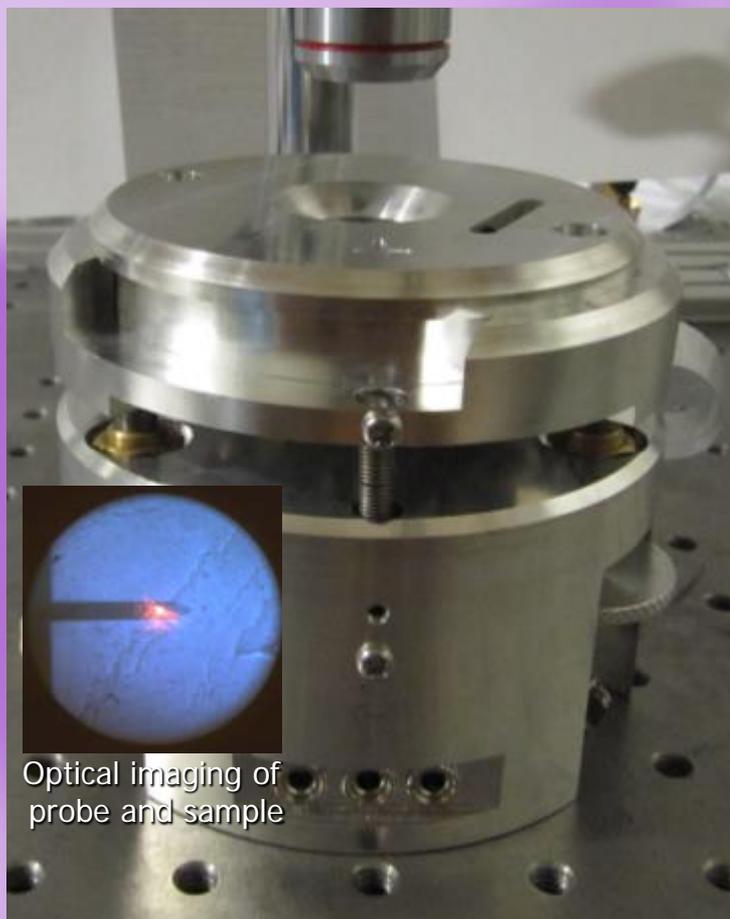
Low voltage scanner:



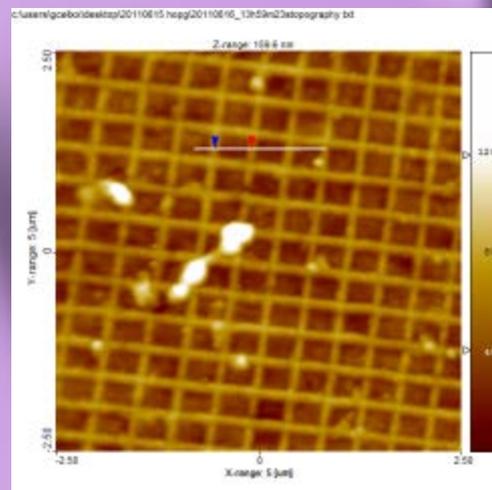
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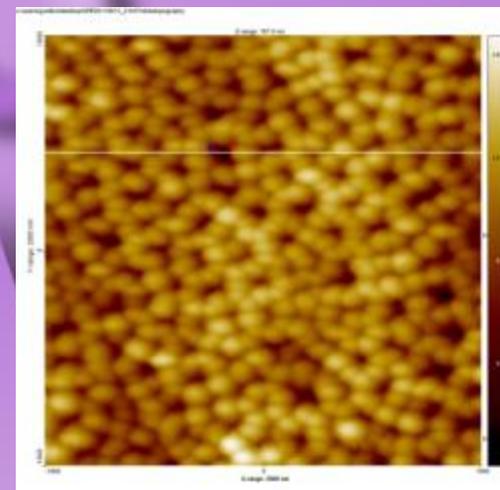
Measurement Results of ADS based AFM with Low Voltage Piezoelectric Scanner



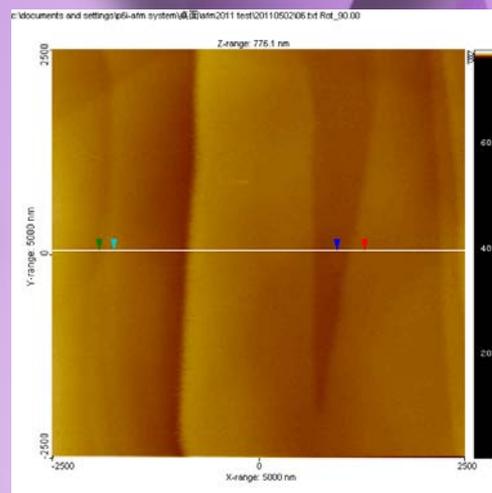
Mechanical part of the Educational AFM with low voltage piezoelectric scanner



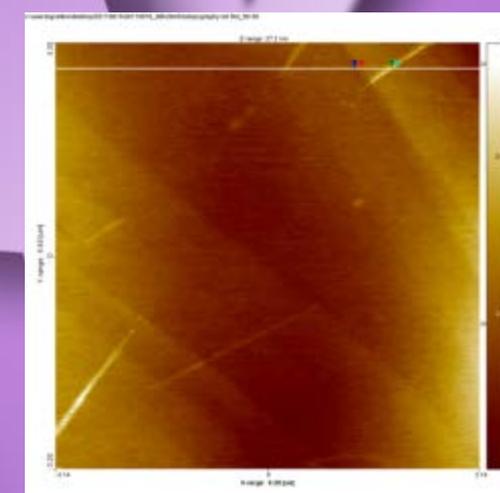
30nm height calibration sample



AAO sample surface



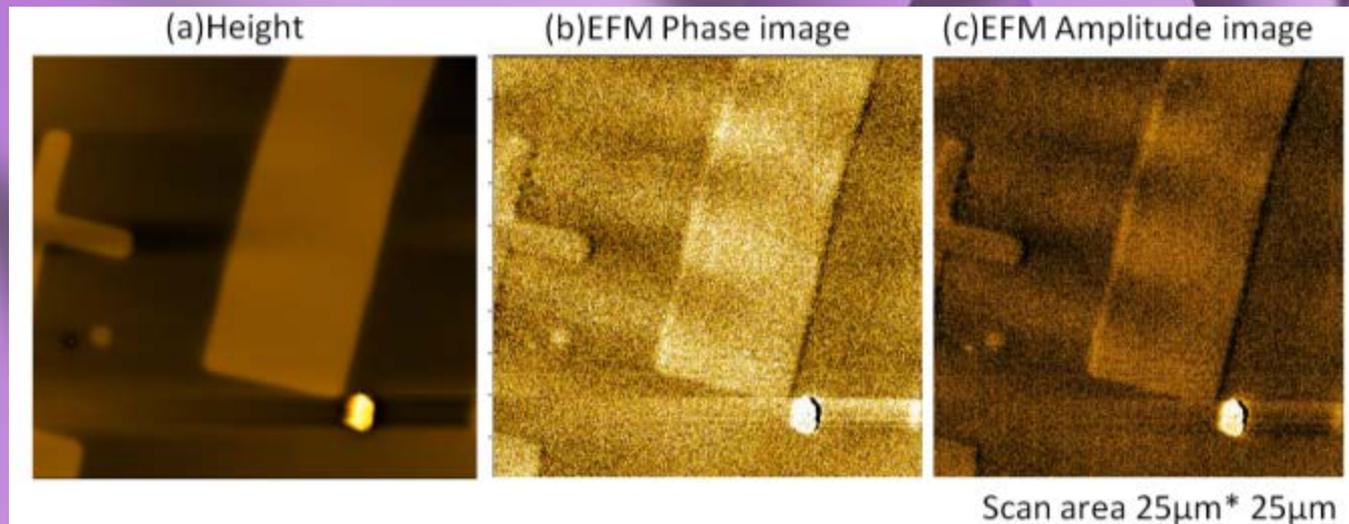
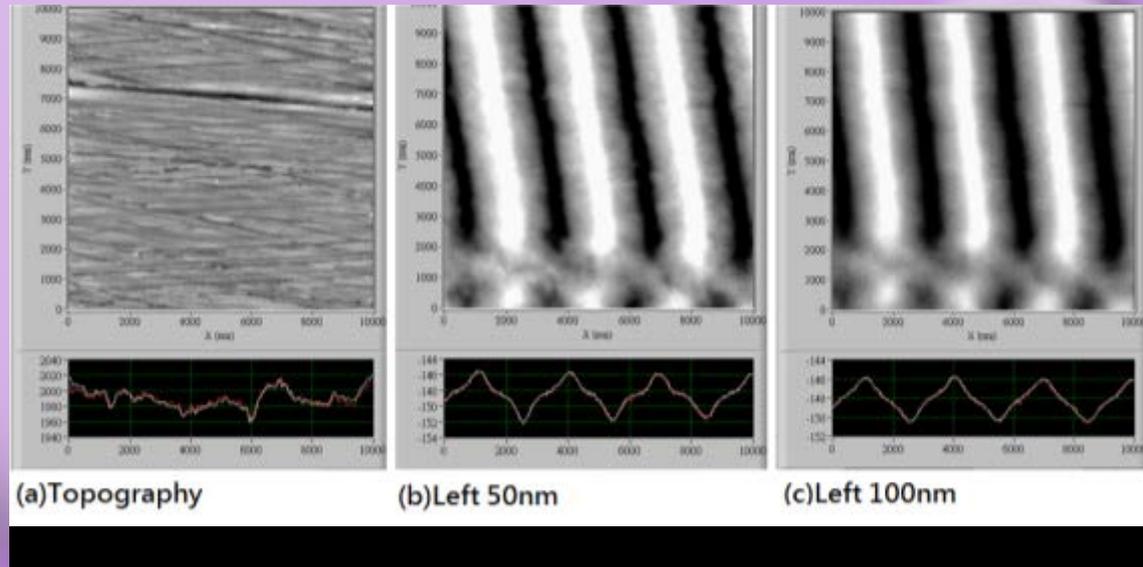
Single atomic step of HOPG



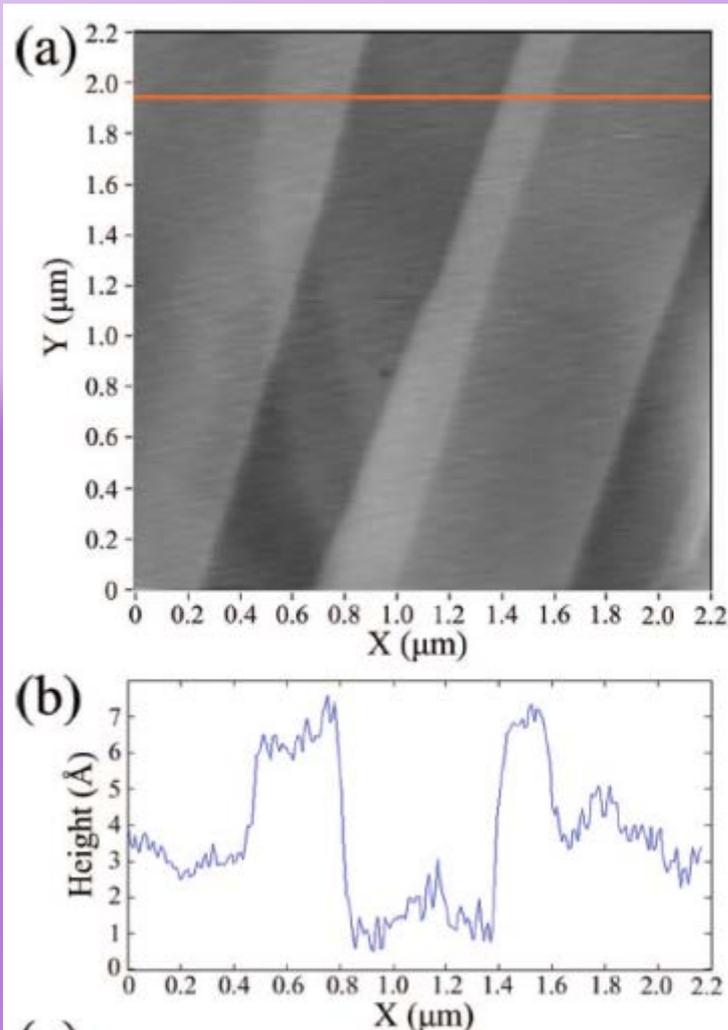
Nano tubes on HOPG



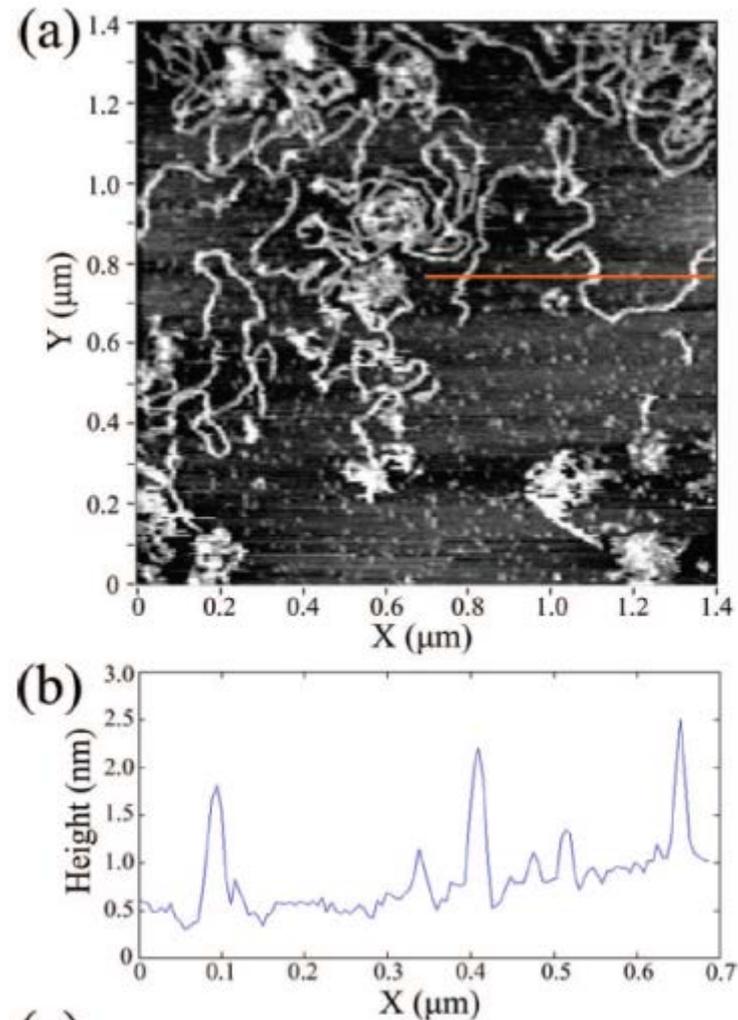
MFM & EFM images



Measurements in liquid environment



HOPG



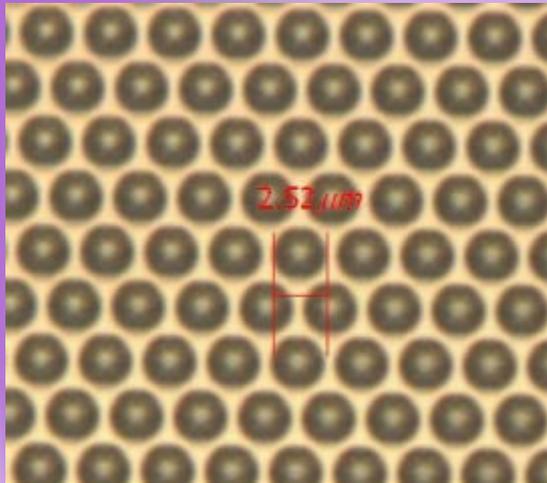
DNA on Mica

HS Liao, KY Huang, IS Hwang, TJ Chang, WW Hsiao, HH Lin, ET Hwu, CS Chang, Review of Scientific Instruments 84 (10), 103709-103709-7 (2013)

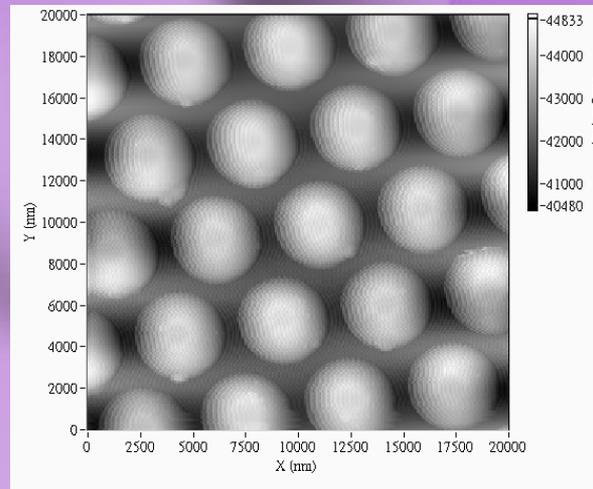
Patterned Sapphire Substrate (PSS)

Measured by IPAS ADS based AFM AFM mode and profiler mode

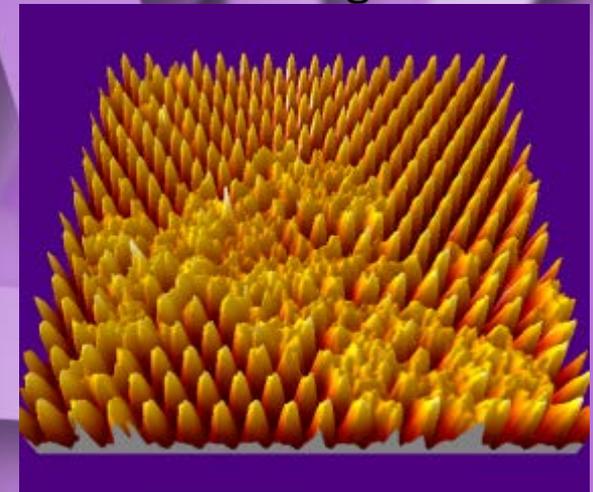
Optical Microscope
Optical Image



AFM Mode
Topography



Profiler Mode
FES Image

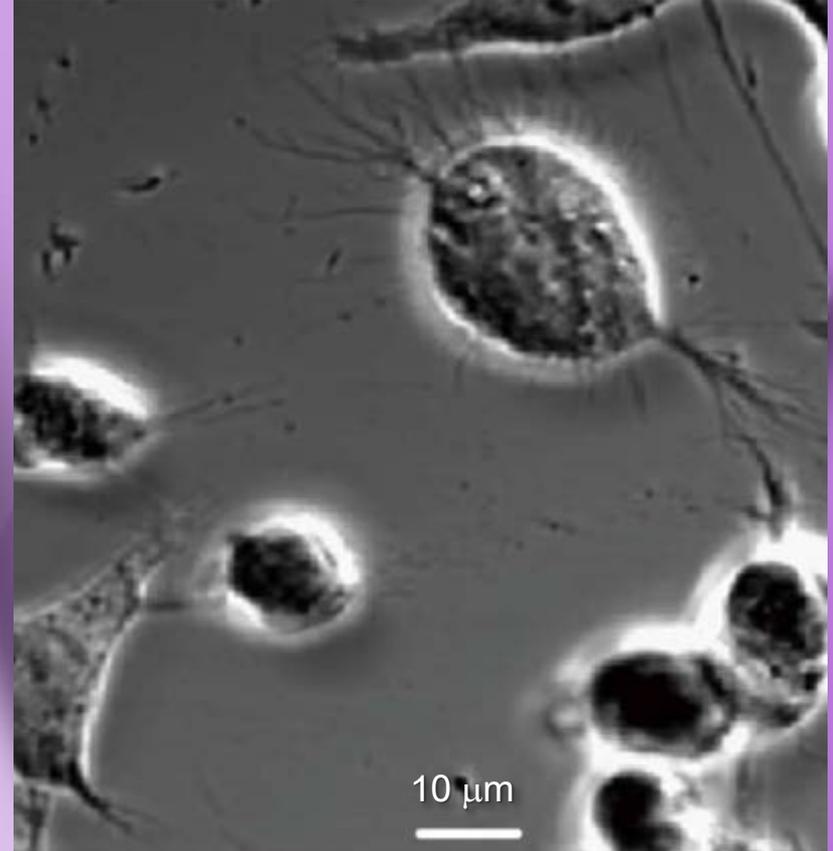


Application of the ADS optical profiler mode

Imaging of astrocytes



1000X OM phase contract image
with Oil lens (Contrast: 0.143)



ADS profiler mode (Contrast: 0.224)

Wesley W. HSIAO, Hsien-Shun LIAO, Hsing-Hung LIN, Yueh-Lun LEE, Chia-Kwung FAN, Chien-Wei LIAO, Po-Yen LIN, En-Te HWU, and Chia-Seng CHANG, Analytical Sciences, 29(9), 885 (2013)

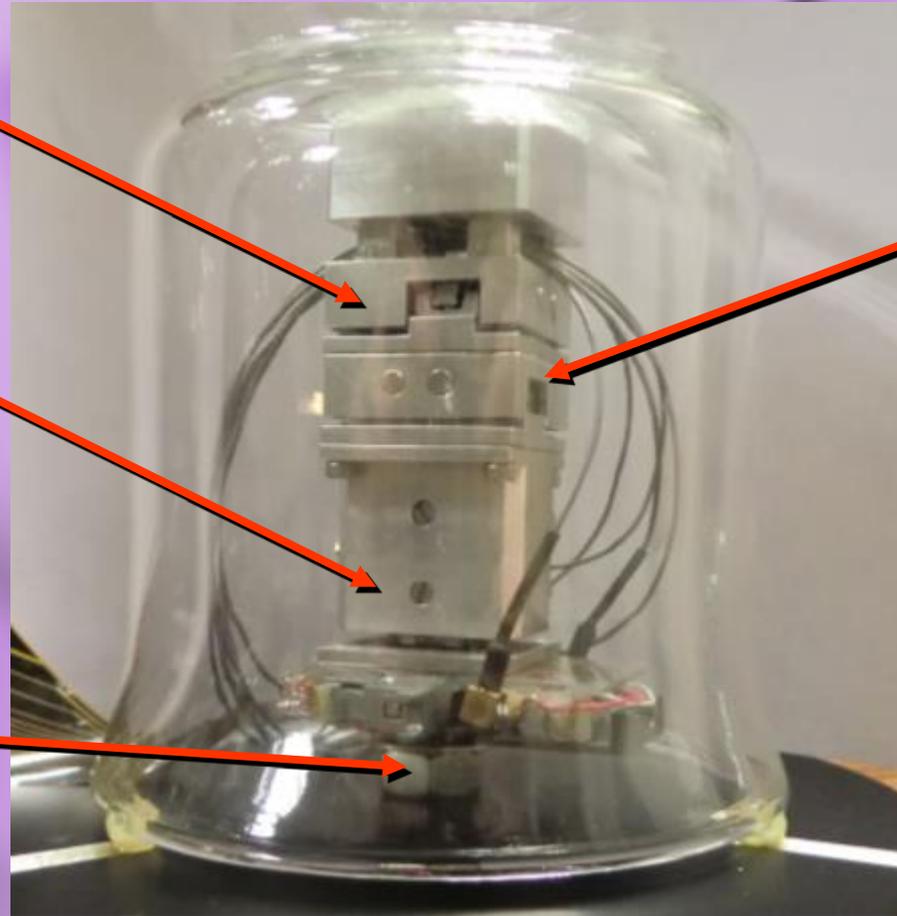
XYZ Actuator for AFM System

X axis coarse/fine scanner

Y axis coarse/fine scanner

Z axis coarse/fine scanner

Sample



X axis for **12 mm stepping** and **10 μm scanning**

Y axis for **12 mm stepping** and **10 μm scanning**

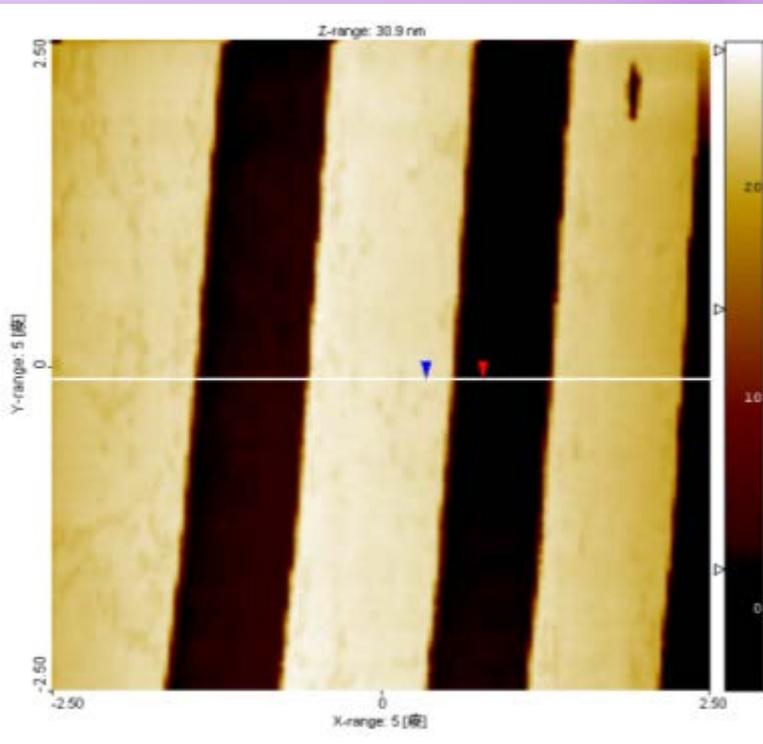
Z axis for **6 mm stepping** and **1.8 μm scanning**

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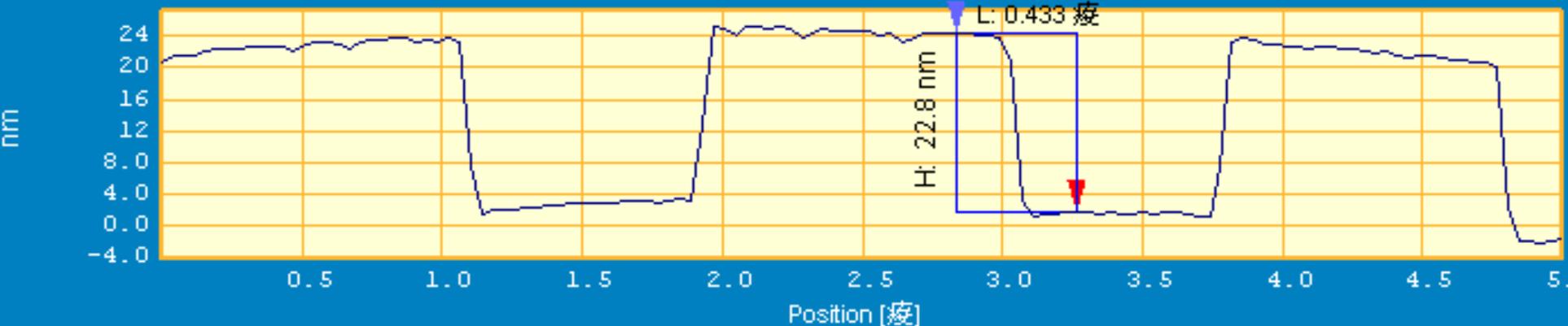
Institute of Physics, Academia Sinica, Taipei, Taiwan



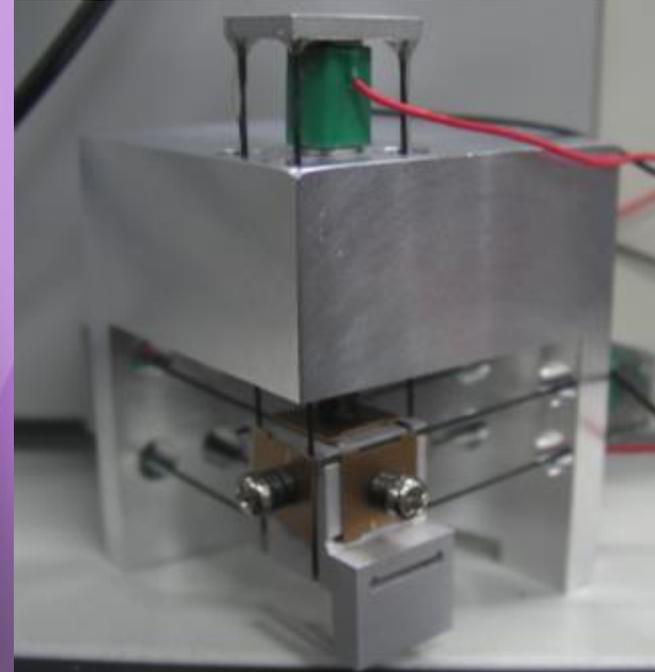
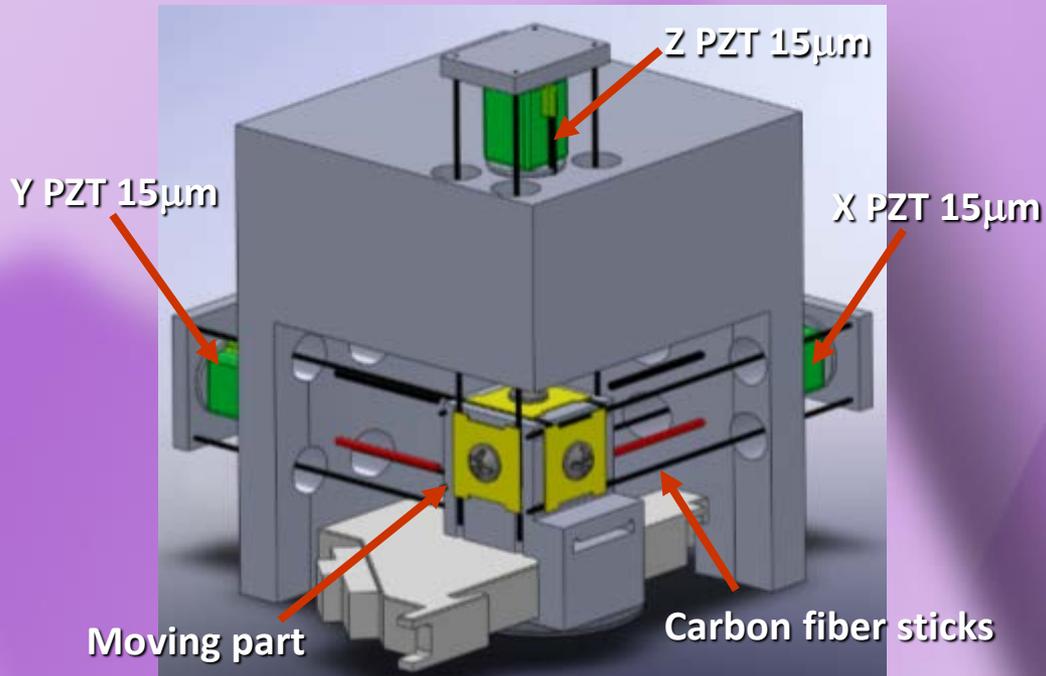
Z calibration data & System parameters



- Probe: Tapping mode
- Frequency: 263.9 kHz
- Scanning range: ~8 nm
- Z sensitivity: 42 nm/V
- Noise level: 0.03 nm (RMS)



High stiffness XYZ Actuator for AFM System



X,Y,Z Coarse adjustment

Range: >4mm (driven by saw tooth wave @ 50V)

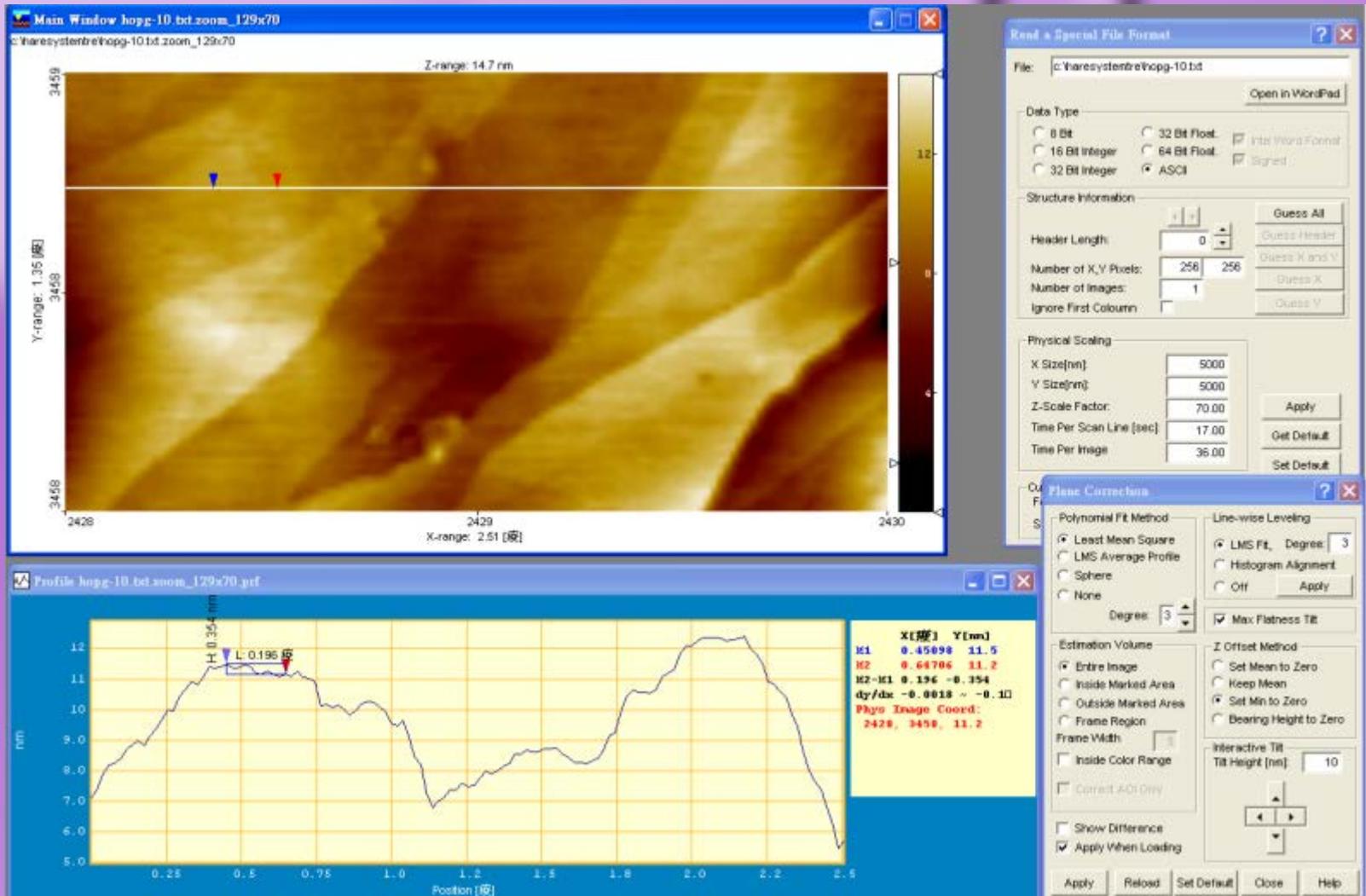
Resolution: < 100nm (need evaluation)

X,Y,Z Fine scan range:

Range: 15mm (driven by triangular wave @ -30~150V)

Resolution: 0.2nm (15mm with 16 bit resolution)

HOPG surface single atomic step



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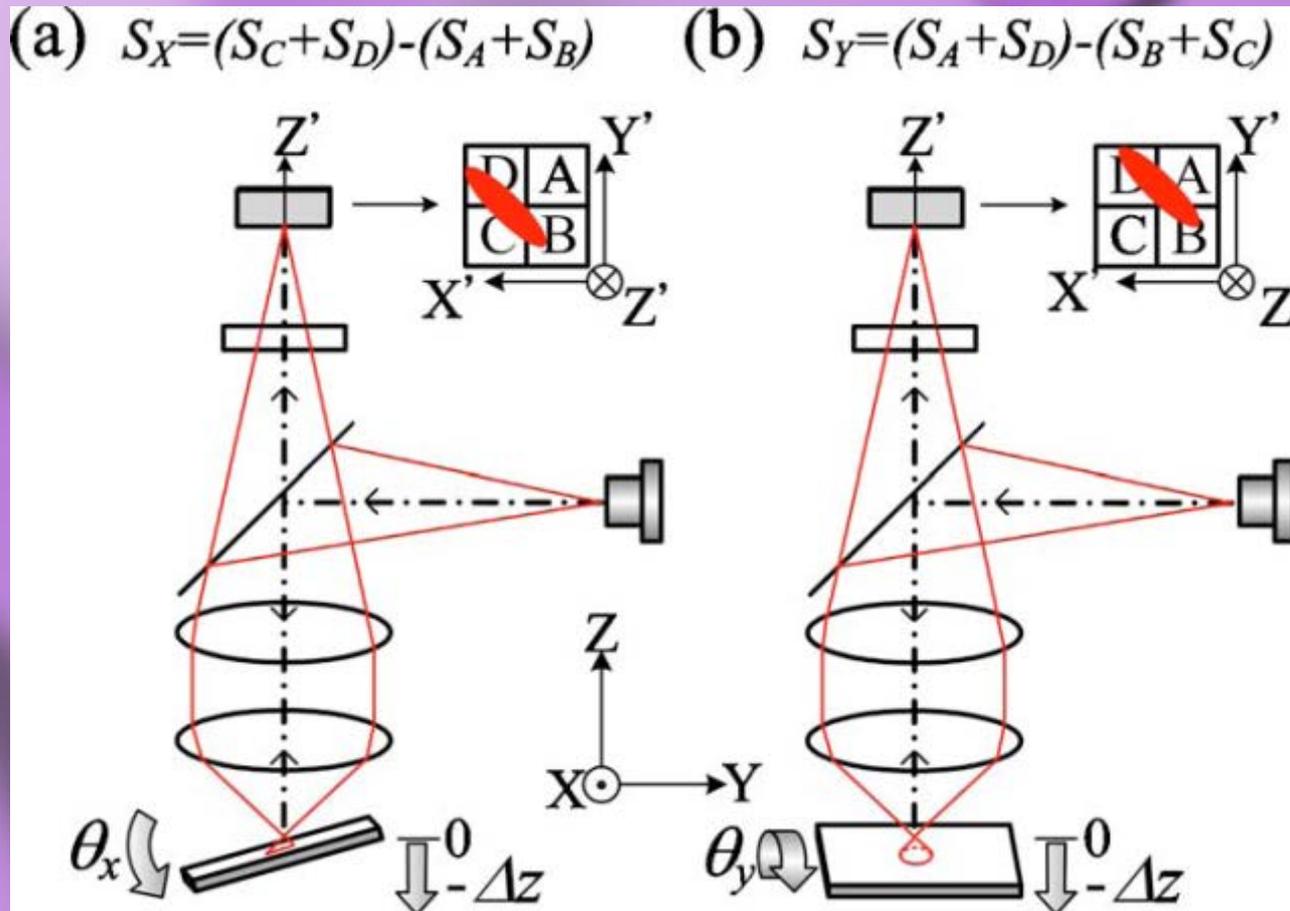
MSA-500 Micro System Analyzer

USD: 200,000

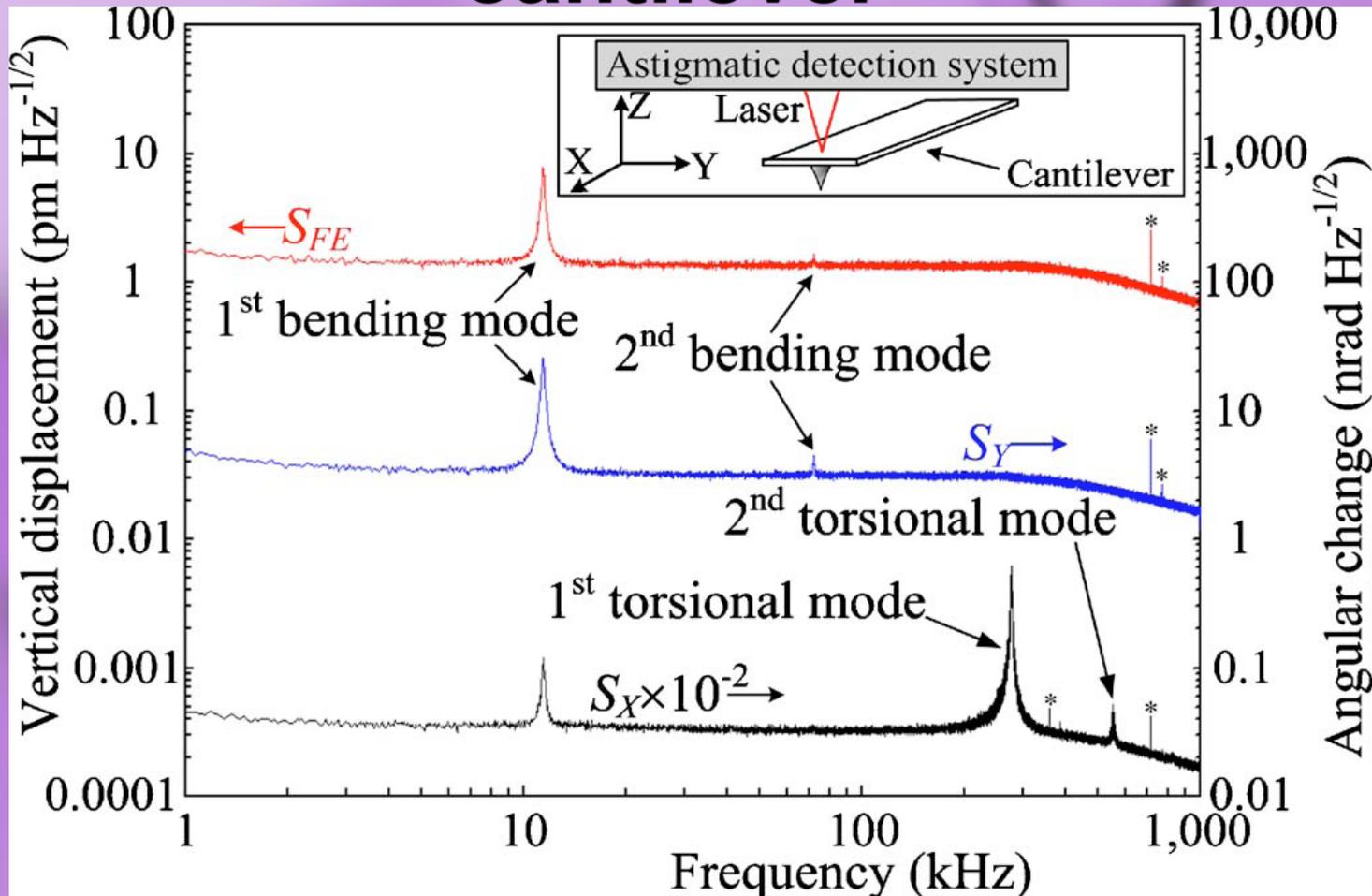


The Micro System Analyzer is the premier measurement tool for the analysis and visualization of structural vibrations and surface topography in micro structures such as MEMS. By fully integrating a microscope with scanning laser doppler vibrometry, stroboscopic video microscopy and scanning white light interferometry, the Micro System Analyzer is designed with an all-in-one combination of technologies that clarifies real microstructural response and topography.

Angular detection mechanism



Thermal noise spectra of an AFM cantilever



Nanotechnology 19 (2008) 115501

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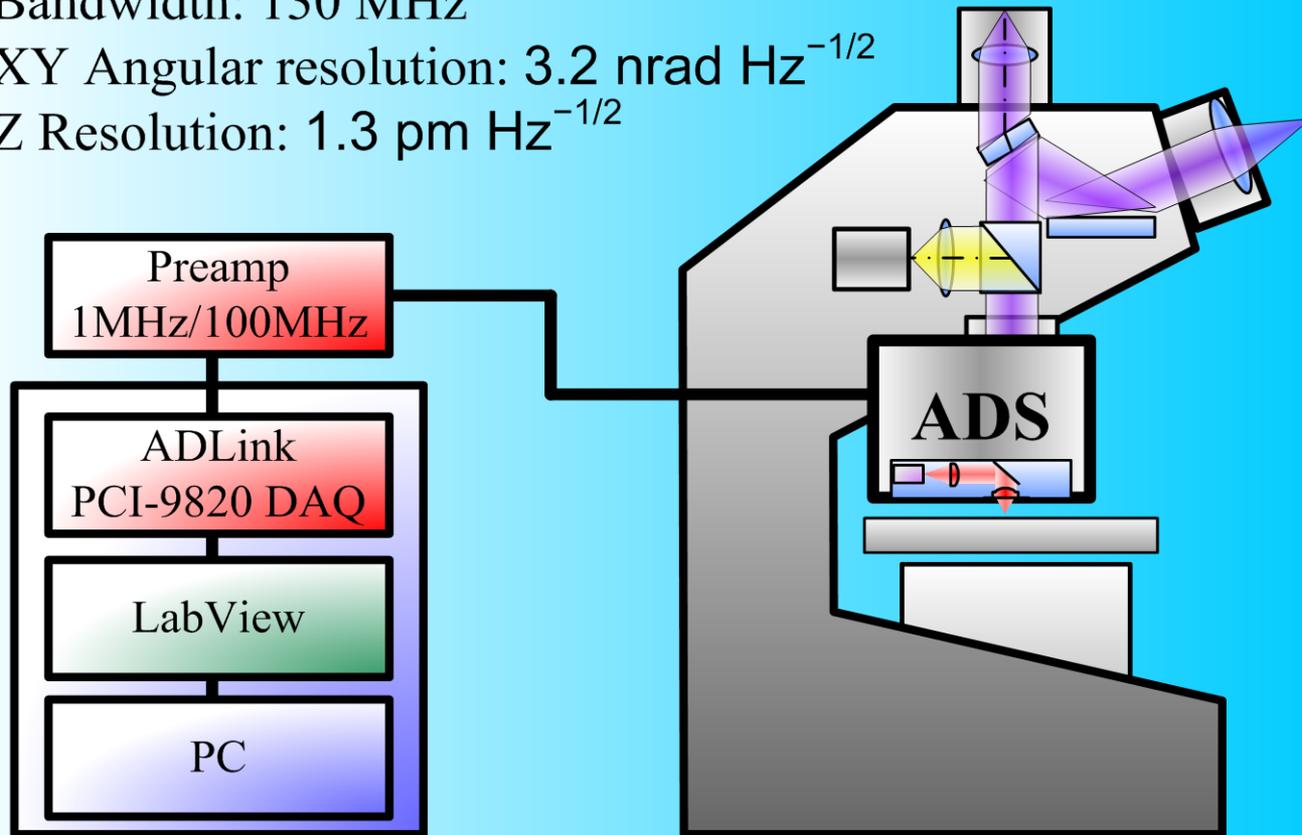
Institute of Physics, Academia Sinica, Taipei, Taiwan



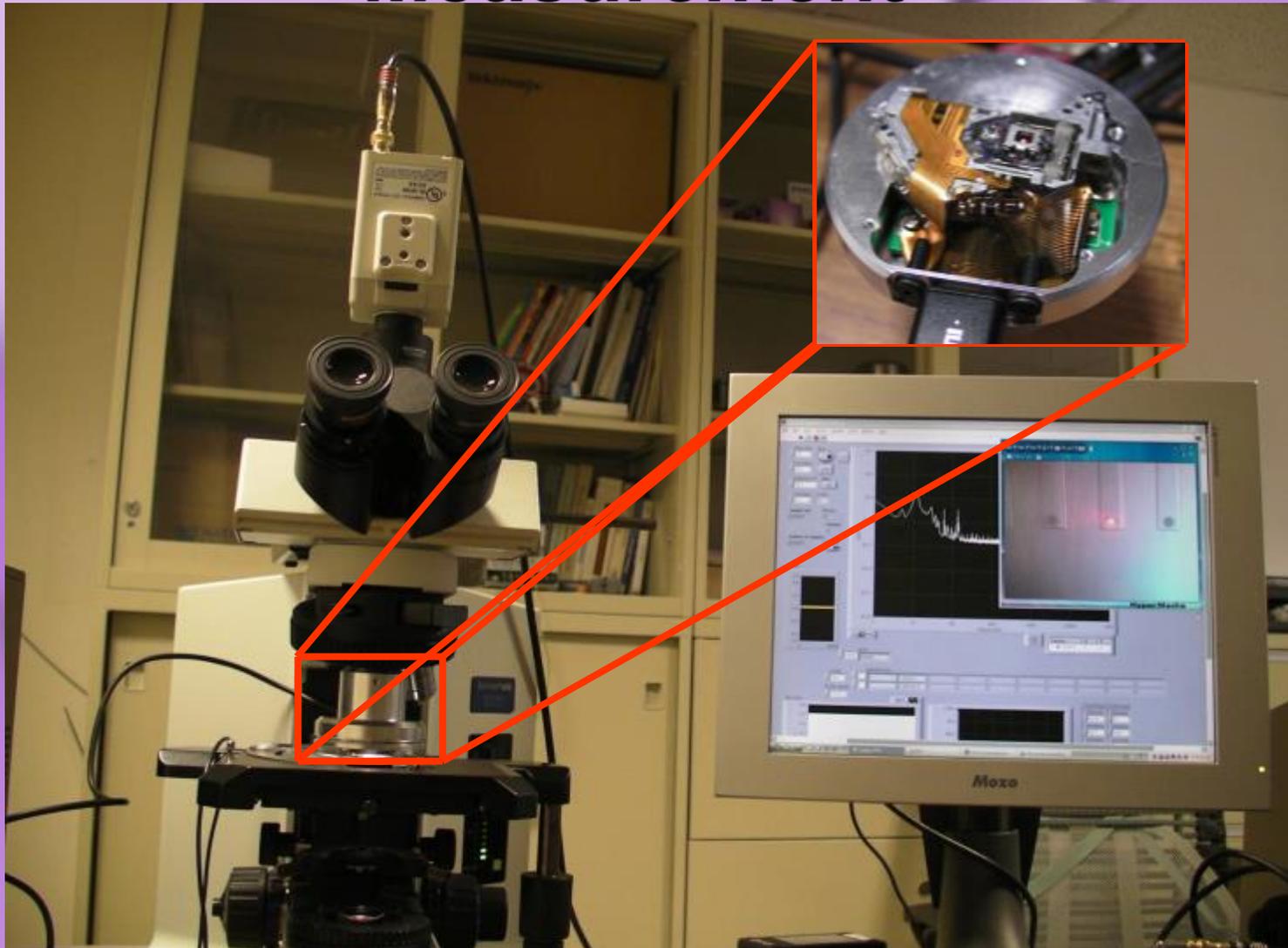
ADS Based Laser Vibrometer

For MEMS characterization

- Spot size: 560 nm (FWHM)
- Bandwidth: 130 MHz
- XY Angular resolution: $3.2 \text{ nrad Hz}^{-1/2}$
- Z Resolution: $1.3 \text{ pm Hz}^{-1/2}$



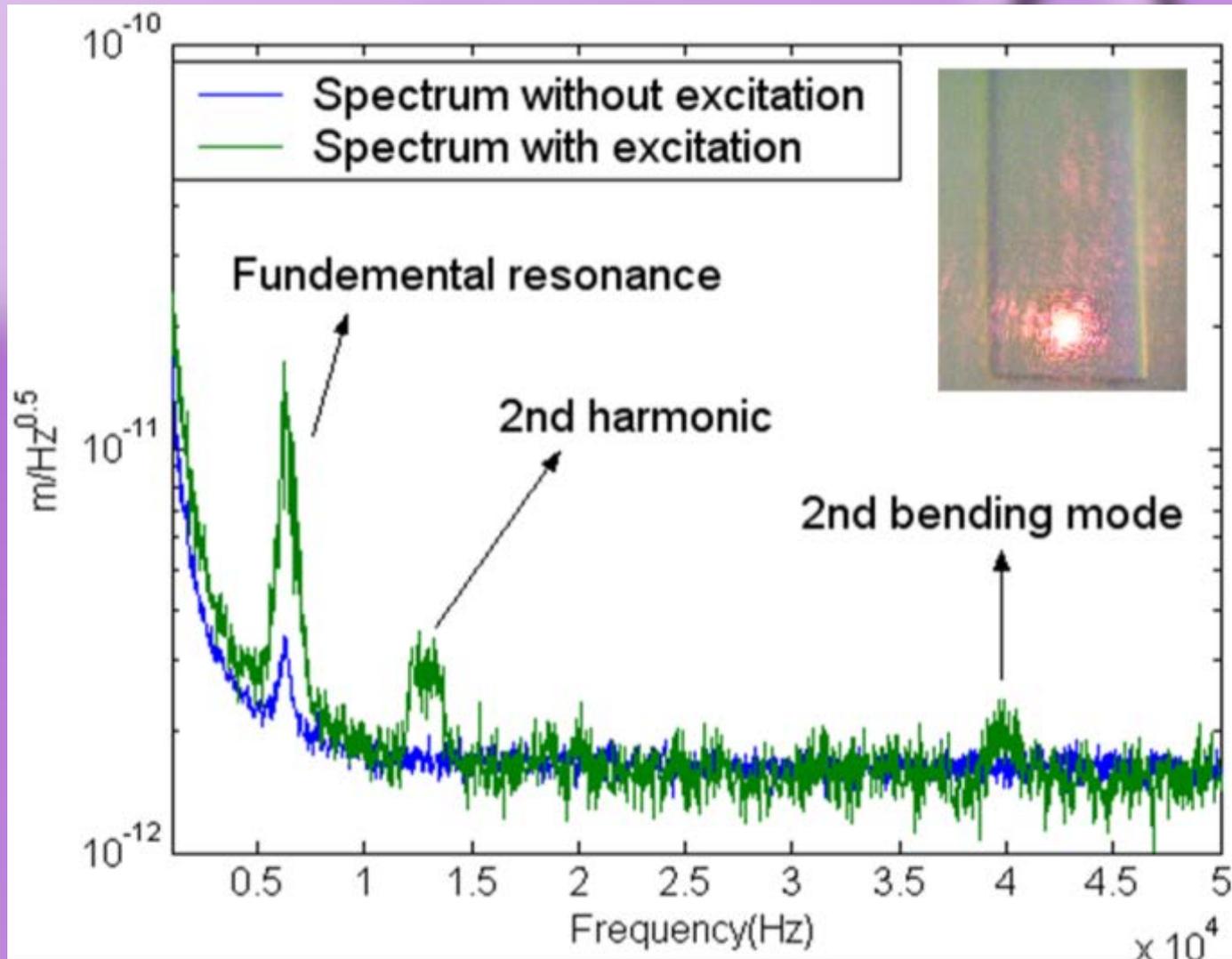
ADS Combined with OM for MEMS Measurement



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MEMS characterization

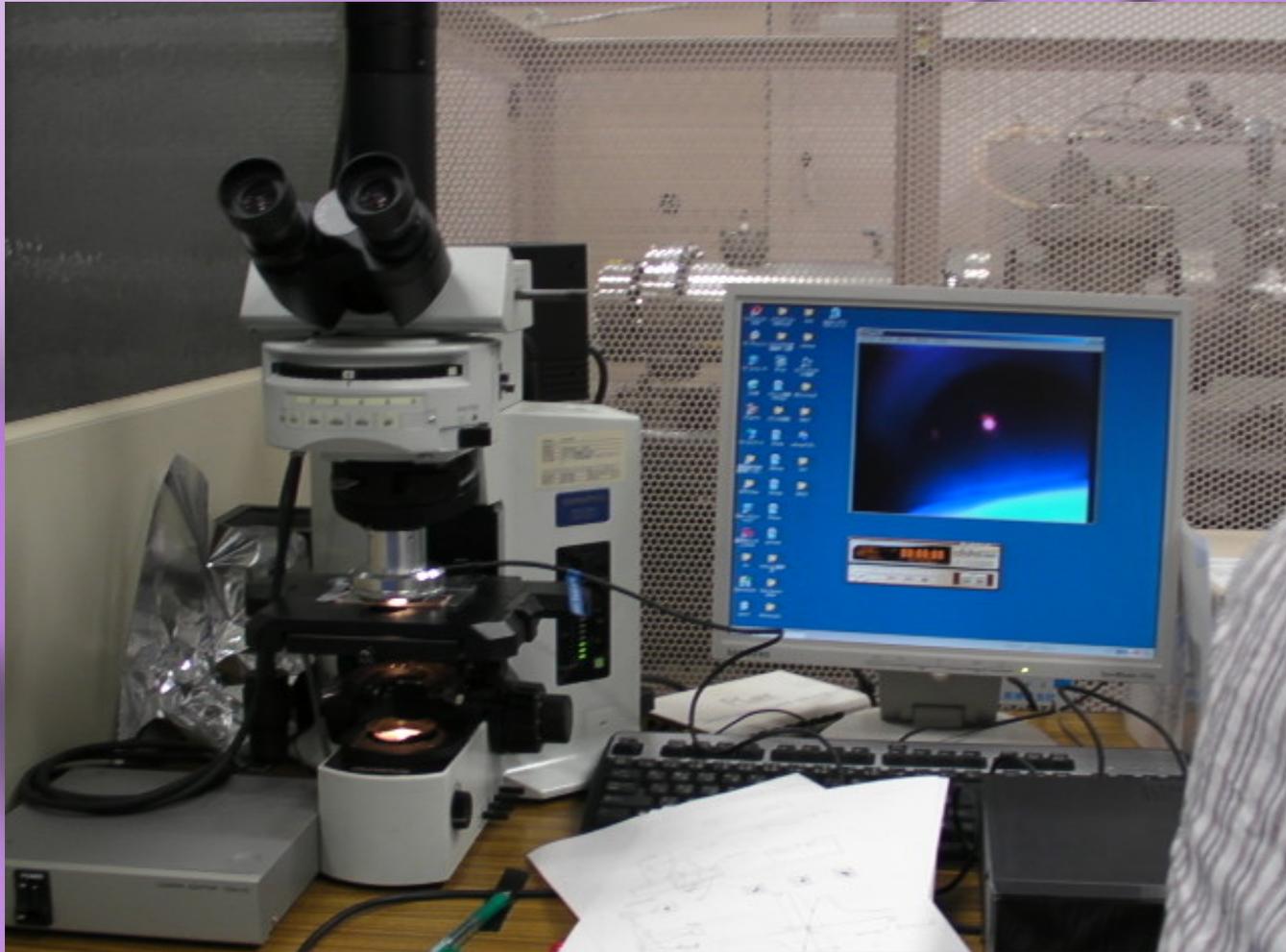


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One Setup in Tokyo University



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Institute of Physics, Academia Sinica, Taipei, Taiwan





Department of Mechanical Engineering, University of Tokyo
Surface and Nano Science Lab
Institute of Physics, Academia Sinica, Taipei, Taiwan

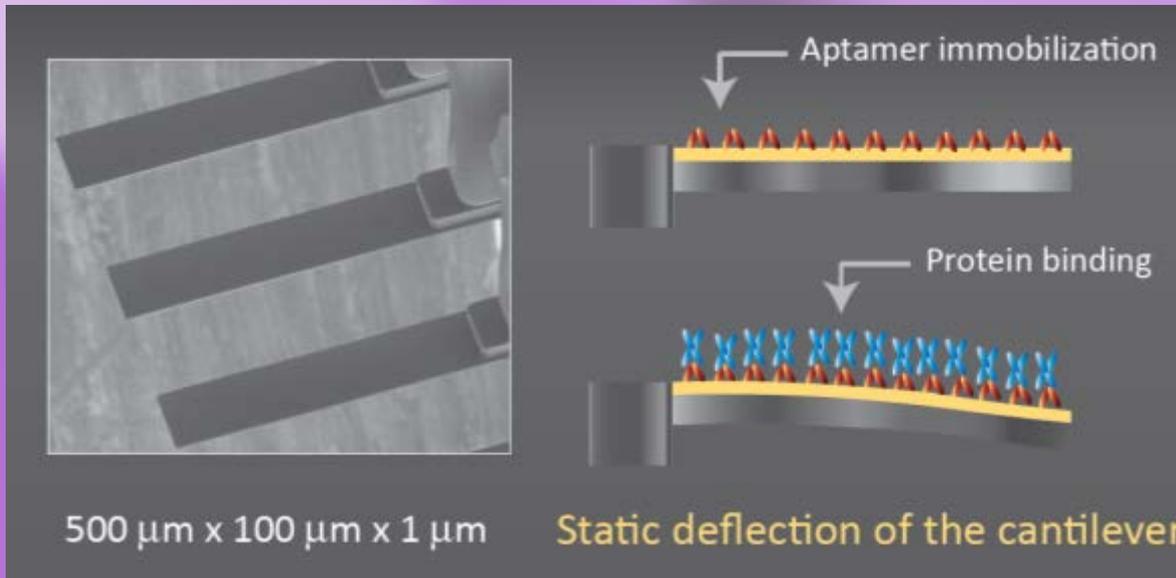


Outline

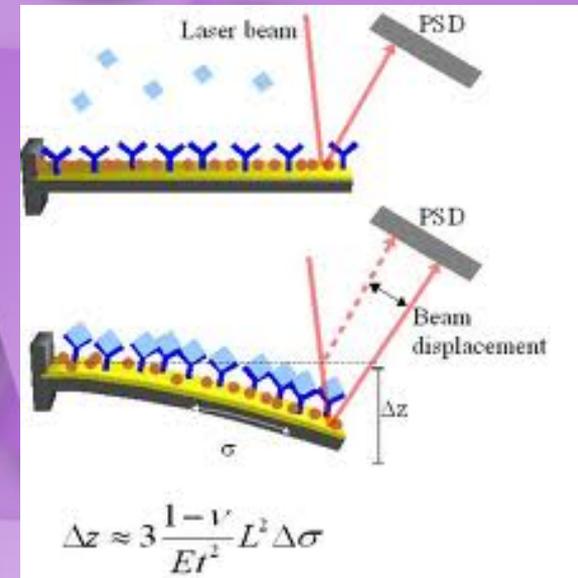
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Micro Cantilever Based Label-free Biochemical Detection



Label-free biochemical detection mechanism



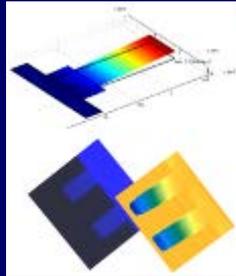
Traditional read out

Traditional read out: 1 min for 1 cantilever

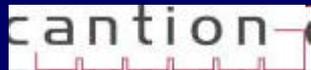
Existing technologies



Optical readout



the displacement of the read-out laser beam provides a fast acquisition and the capability to detect of the full 3D profile of cantilever arrays of any size, shape and number of elements.



Piezoresistive readout



Easy replacement of the chip.
Possibility of working in liquid and gas flow.



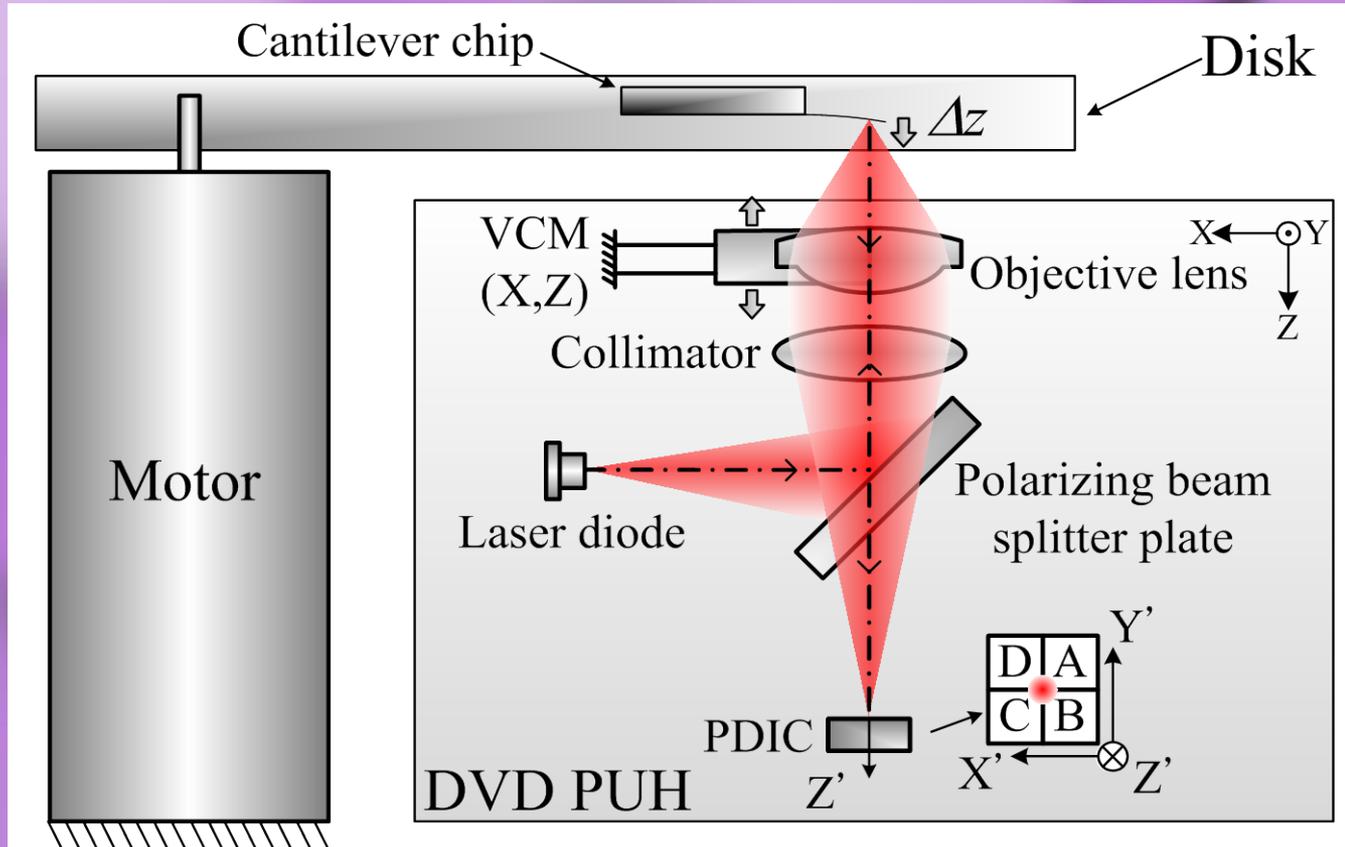
Optical readout



Integrated temperature control.
Automated sample handling system.
Possibility of working in liquid and gas



ADS Based Bio-sensing Read-out Setup



ADS Based read out: 500 cantilever per second

Danish Government to Invest 17 million kr. on this System

Ingeniøren Log ind Opret ny bruger

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BIOTEK | BYGGERI | ELEKTRONIK | ENERGI & MILJØ | FORSKNING | FØDEVARER | IT | KARRIERE | PRODUKTION | RUMFART | TRANSPORT

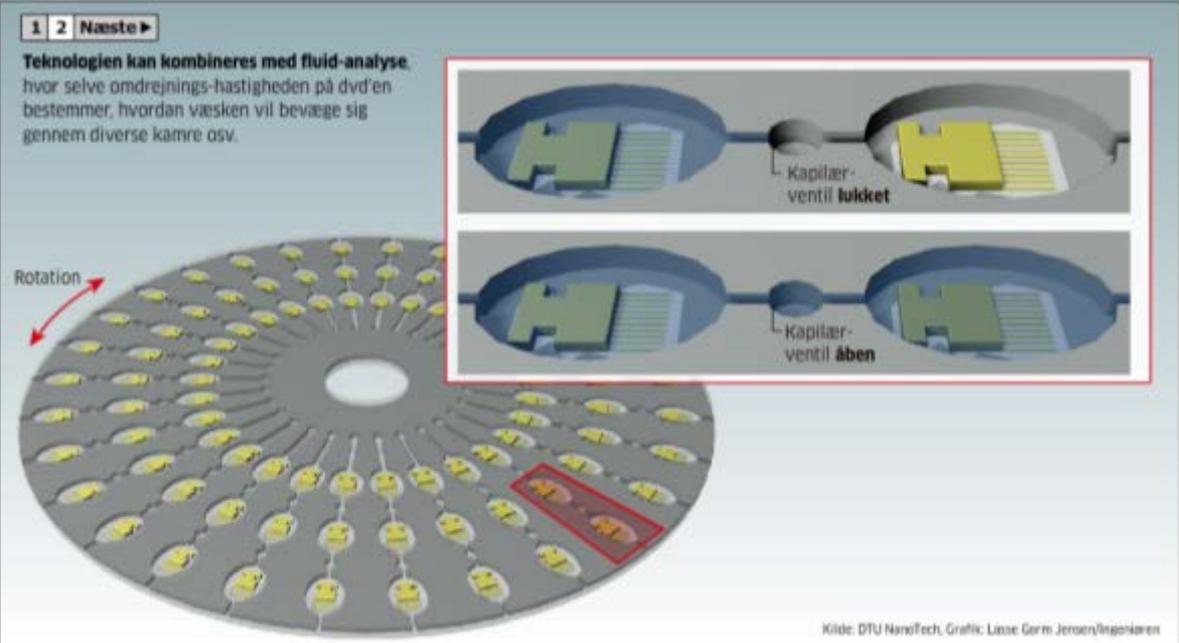
[UDSKRIV](#) | [DEL PÅ FACEBOOK](#) | [SEND TIL VEN](#) | [KOMMENTARER \(0\)](#)

Forskere vil lave kemisk analyse på dvd-skiver

Af Lasse G. Jensen, søndag 18. dec 2011 kl. 10:00

1 2 Næste ▶

Teknologien kan kombineres med fluid-analyse, hvor selve omdrejnings-hastigheden på dvd'en bestemmer, hvordan væsken vil bevæge sig gennem diverse kamre osv.



Kilde: DTU NanoTech, Grafik: Lasse Gorm Jensen/Ingeniøren

Læs også:

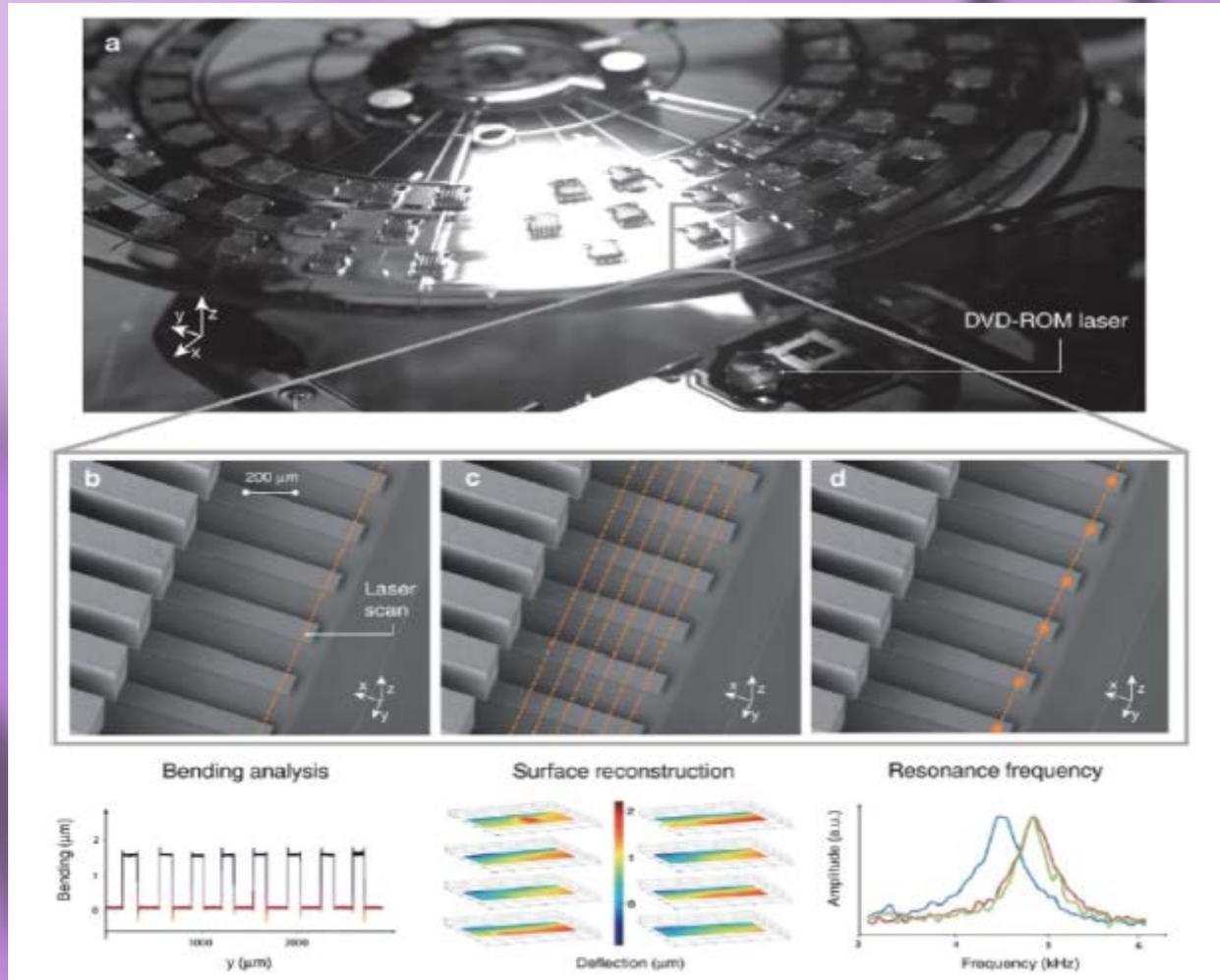
**Lab on a CD
Sample preparation**

<http://ing.dk/artikel/125118-bombejaeger-vil-ogsaa-lede-efter-hormoner-og-sygdomme>

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Static Bending, 3D Surface Reconstruction and Resonant Frequency Characterization

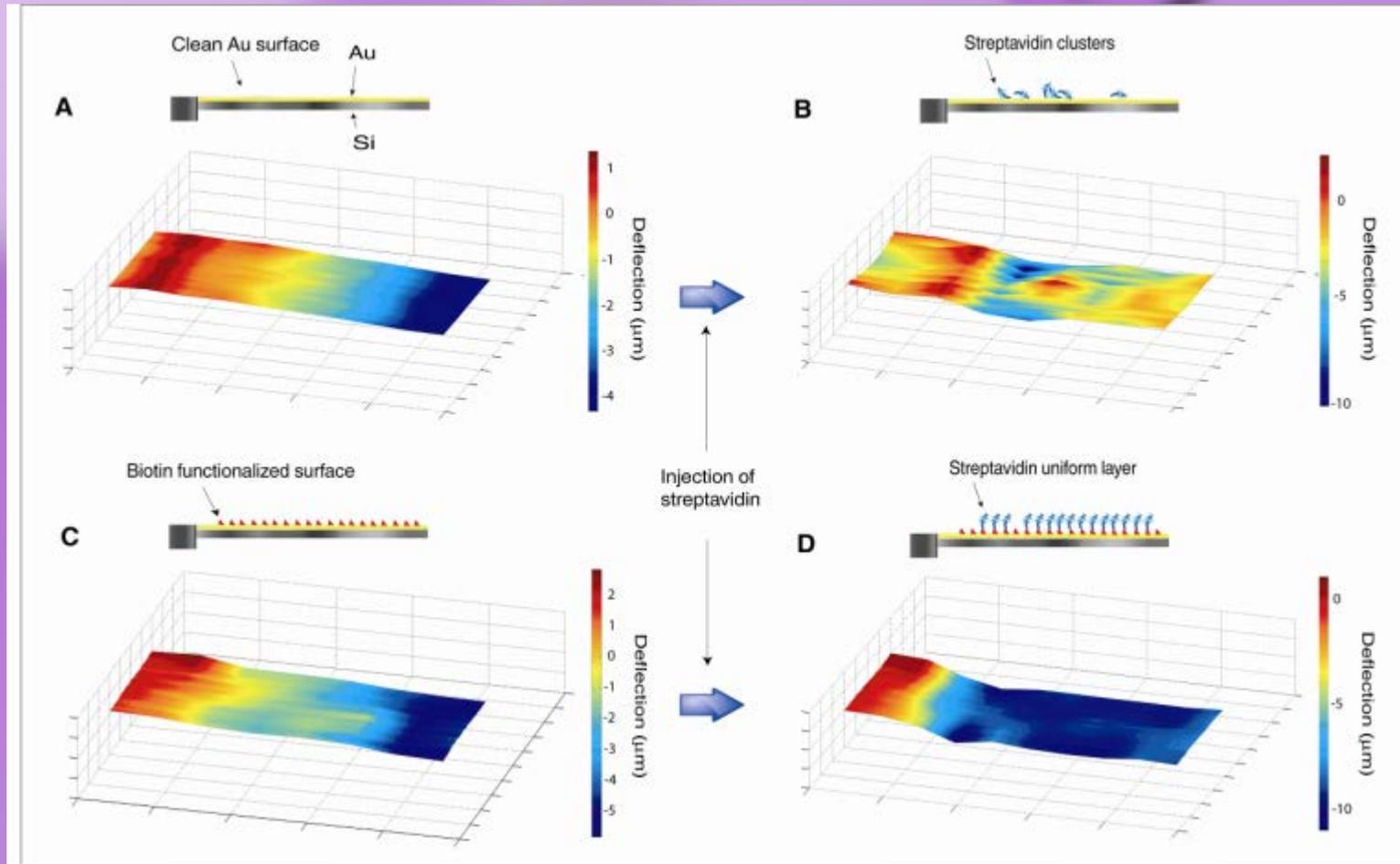


F. G. Bosco, E.-T. Hwu, C.-H. Chen, S. Keller, M. Bache, M. H. Jakobsen, I.-S. Hwang and A. Boisen, "High throughput label-free platform for statistical bio-molecular sensing," (2011) Lab on a Chip (SCI) Vol. 11, pp. 2411-2416. (IF:6.306)

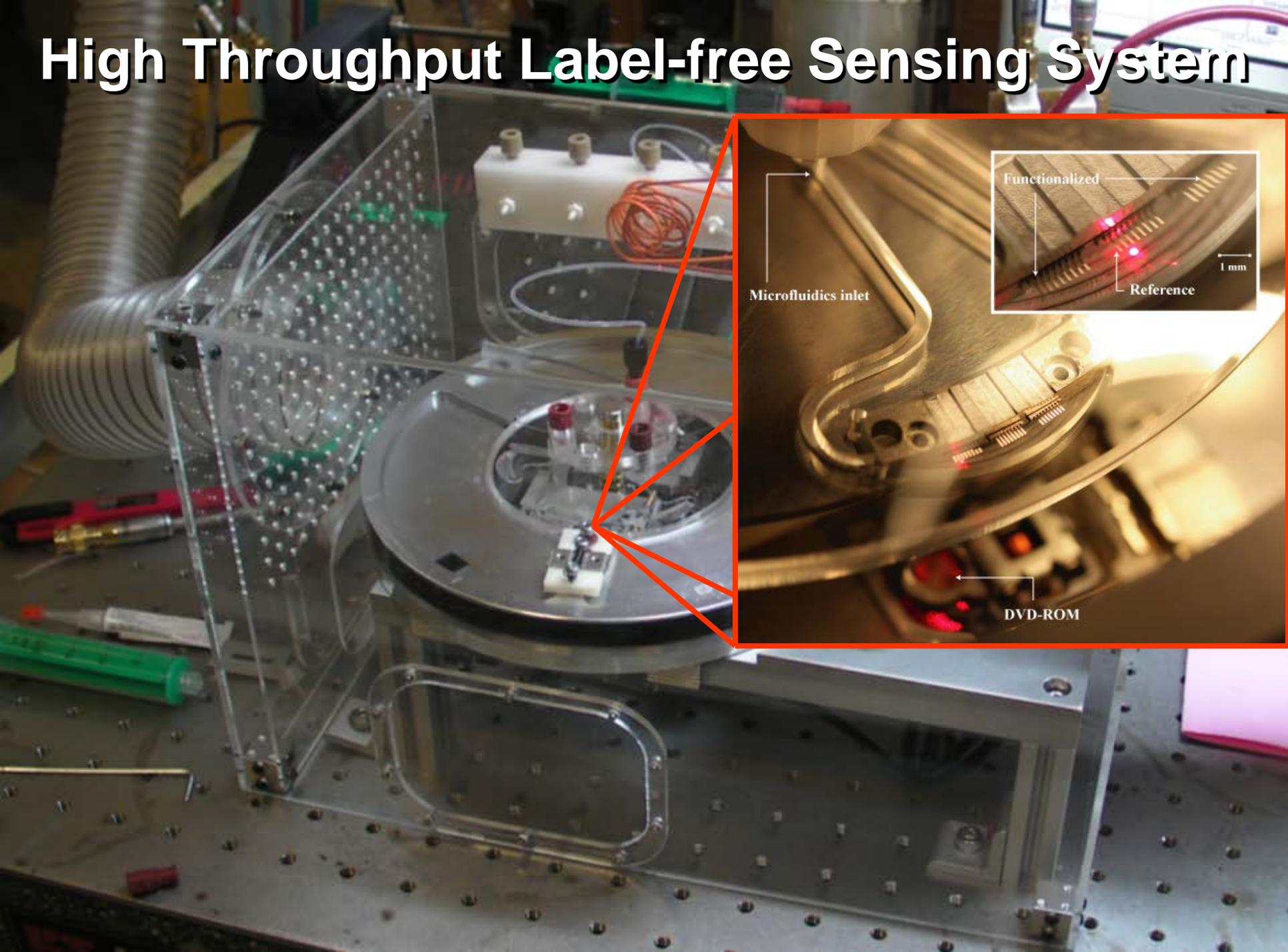
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Measurement Results



High Throughput Label-free Sensing System



Microfluidics inlet

Functionalized

Reference

1 mm

DVD-ROM



Surface and nanoscience Lab

- Dr. En-Te Hwu
- Ching Shou Chen
- Prof. Hwang



Nanoprobes Group

- Prof. Boisen
- Stephan Keller
- Micheal Bache

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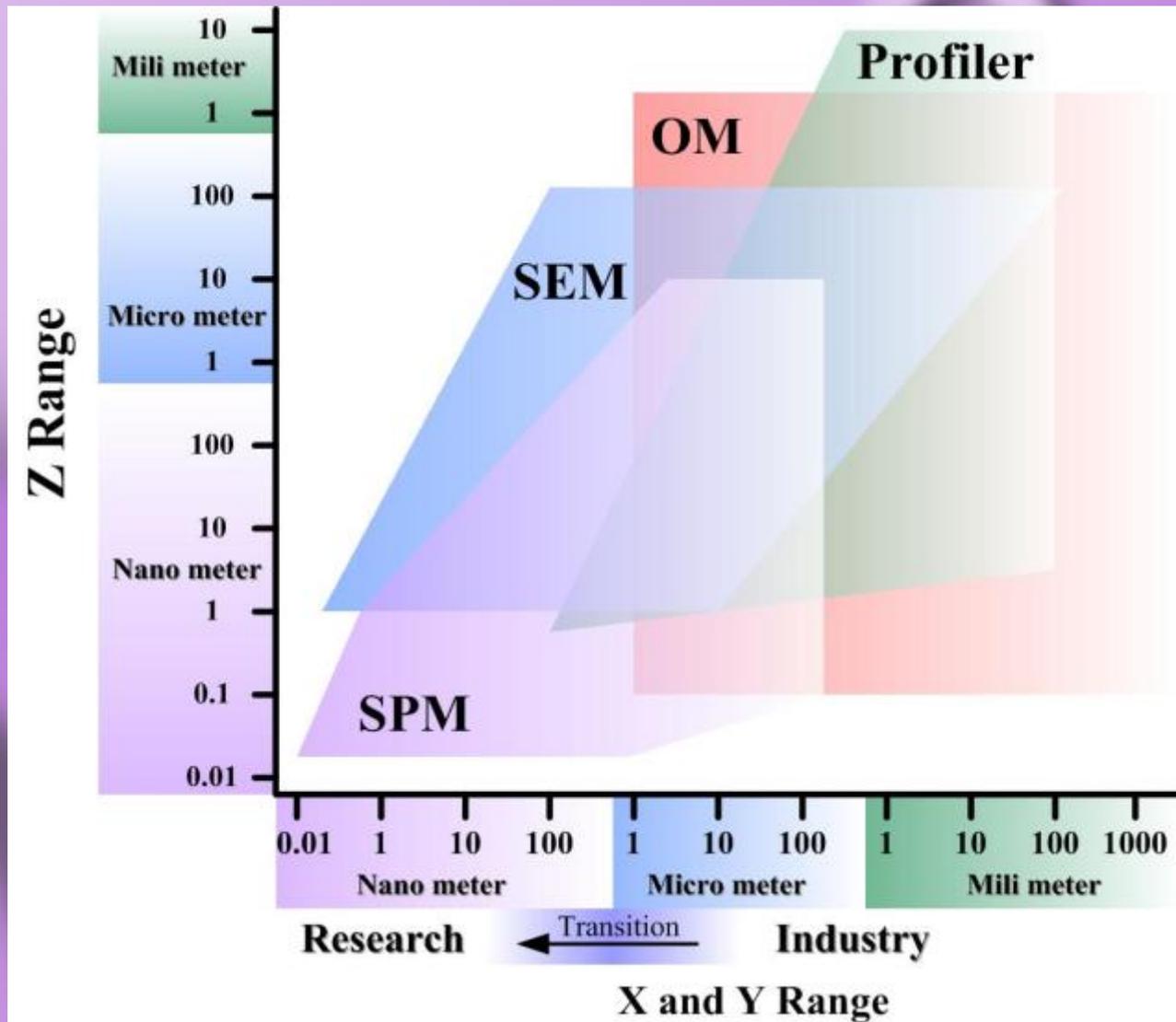


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Comparison of Different Techniques



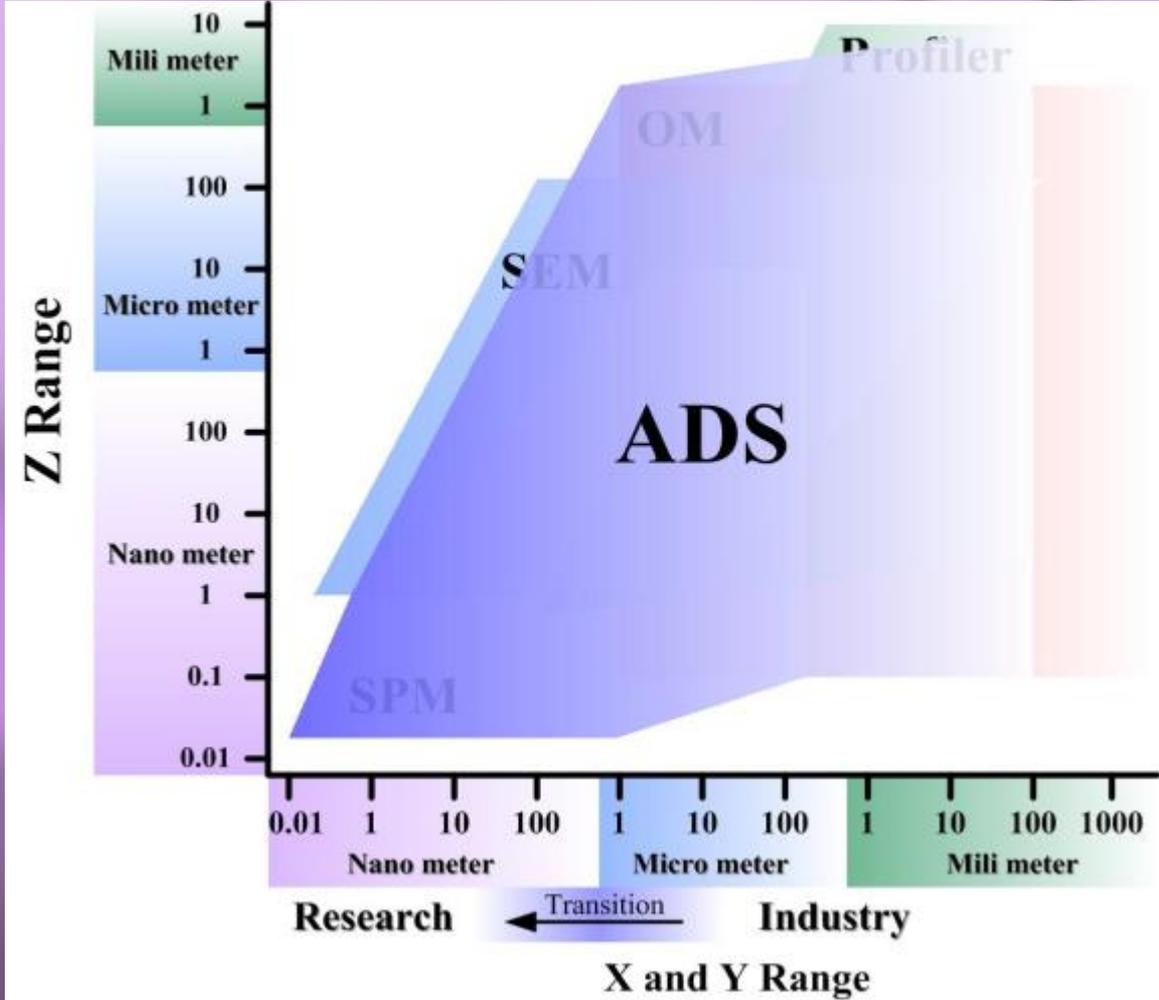
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Conclusions:

Millimeter-Micrometer-Nanometer



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Thank you !!



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